

# Single-Event-Effects Test Report

## **R6, 250V, N**



## September 2005

## Table of Contents

Introduction .....	1
Test Method .....	1
Test Plan .....	1
Test Facility .....	2
Results .....	2
SEE Data Run Number Index .....	3
Device Operating Area .....	3
Conclusions .....	3
Appendix A - Log Sheets (SEE Run Data) .....	7
Appendix B - TAMU Cyclotron Facility Data and Graphs .....	12
Appendix C - I.R. Test Plan and Procedure .....	21
Appendix D - Test Circuit Schematic Diagram .....	26
Appendix E - TAMU Cyclotron Ion Species, Surface LET & Range ...	28
Appendix F - Post-SEE Electrical Measurements .....	32

## INTRODUCTION

On October 5<sup>th</sup> 2004, April 30<sup>th</sup> 2005 and August 23<sup>rd</sup> 2005, International Rectifier Corp. (IR) tested several product types for Single Event Effects (SEE) hardness. The irradiation was performed at Texas A & M University, using the K500 Superconducting Cyclotron. The Silver (Ag), Xenon (Xe) and Gold (Au) ion species with three (3) different combinations of Energy, Range and Linear-Energy-Transfer (LET) levels was used to characterize and verify the SEE hardness of each product type. The product types submitted for evaluation and this report are included in Table 1 below:

**Table 1 Product Types Tested**

<b>Product Type</b>	<b>BVDSS Rating</b>	<b>Gen. / Channel / Process</b>	<b>Wafer Lot</b>
IRH67264	250 Volts	R6 / N / 250 Volts	ER51915
IRH67264	250 Volts	R6 / N / 250 Volts	ER54738

The wafer lots noted above are the lots from which the test samples originated. For each product type, the results of testing herein are applicable to all other wafer lots having the same design and process.

Additionally, Mr. Louis Jaquish of Defense Supply Center Columbus (DSCC-VQE) has performed an audit of IR for the purpose of assigning lab suitability and has granted IR a Letter of Lab Suitability for Test Method 1080 in June 1998. Similarly, Mr. Thomas Hood had grant IR a Letter of Lab Suitability for Test Method 1080 in April 2005 for Texas A&M Cyclotron Facility.

## TEST METHOD

The test method used as a guide in developing the test plan is MIL-STD-750, Test Method 1080. The test method establishes the basic requirements for the performance of the test. Additionally, DSCC has established a minimum acceptance level of three (3) devices for each insitu bias condition. Test method 1080, in conjunction with DSCC requirements, was utilized to write the test plan.

## TEST PLAN and PROCEDURE

The test plan is included in Appendix C. In summary, the testing occurred in the following manner: All devices / test samples were built and electrically tested in TO-3 packages. The lid was removed from each test sample at the test site or the samples were produced without the lid. Up to 18 test samples were loaded onto the test board and placed into the beam line, under high vacuum conditions. The desired test sample was positioned into the beam line, and when ready the beam shutter was removed beginning the irradiation of the test sample. Once the desired fluence was achieved the beam was automatically shuttered and the bias removed. The biasing equipment then subjected the test samples to gate stresses up to 20V.

The Ion with its LET and Energy must be selected for a Range of worst-case SEE Responses.

TEST FACILITY

The K500 Superconducting Cyclotron is equipped with the necessary dosimetry to ensure the ion beam is meeting the customer expectation. A printout of the runs, included in Appendix B, also includes the beam parameters, i.e., LET, energy, Range, etc., for each run. Table 2 summarizes the 3 beam criteria for the ion species properly selected and utilized.

**Table 2. Ion Beam Criteria**

<b>Ion</b>	<b>TAMU Set-Up</b> A MeV / nucleon	<b>LET</b> MeV/(mg/cm <sup>2</sup> )	<b>Energy</b> MeV	<b>Range</b> μm
<b>Ag</b>	15	43	1217	112
<b>Xe</b>	25	43	2440	205
<b>Xe</b>	15	59	823	66
<b>Au</b>	15	90	1480	80

The fluence and flux specified for this test was 3E5 ions/cm<sup>2</sup> and 1E4 ions/cm<sup>2</sup>/sec, respectively. The beam diameter was set to cover the whole die-attachment area. The angle of incidence was set to zero (normal to the die surface).

RESULTS

The insitu bias conditions, where 0 failures occurred for each product type, are shown in Table 3. These results are shown graphically in Figure 1 as a plot of the Safe Operation Area (SOA). Each point on the graph, or insitu bias condition, has been verified by irradiating and subsequent electrical testing of a minimum of 3 devices, with no valid failures allowed. The devices were returned to IR and tested using production ATE. The results of the test were inspected and matched to the notes taken during the test, see Appendix F. The post-irradiation data correlates with the expected test results.

It should be noted that acceptance is assumed for product types operating at conditions below those tested herein. For example the IRH67264 was not tested under the V<sub>GS</sub> bias conditions of 0V through -10V with the Ag ion of LET=43 MeV/(mg/cm<sup>2</sup>). The test engineer made a calculated risk assessment based on SEE Process History & SEE results at lower LET and chose to begin characterization and verification at V<sub>GS</sub> = -15V. The insitu acceptance at the -15V was then extended to the lower V<sub>GS</sub> bias voltages.

Furthermore the extension of more stressful conditions to less stressful conditions shall also apply to the LET conditions of the various ion species. For example successful operation using the Au ion (LET of 90 MeV/(mg/cm<sup>2</sup>)) shall also imply that any other ion with a LET < 90, shall also be acceptable and not require verification.

The different runs and respective test conditions are all tabulated in Appendices A and B. Table 4 may be used as an index to identify which runs apply to a specific product type with a specific ion. Unlisted Runs are not related to this report.

**Table 3 Device IRH67264 (R6, 250V, N) Insitu Bias Conditions ( $V_{DS}$  vs.  $V_{GS}$ ) with Ion Species**

Wafer Lot	Ion (LET)	VGS=0V	VGS=-5V	VGS=-10V	VGS=-14V	VGS=-15V	VGS=-17V	VGS=-20V
ER51915	Ag (43)	Qualified	Qualified	Qualified	Qualified	250 V	100 V	50 V
	Xe (59)	Qualified	Qualified	250 V	Qualified	50 V		
	Au (90)	Qualified	75 V					
ER54738	Xe (60.0)	SEB- Immuned @ VDS≤260V				SEB & SEGR Immuned @ VDS≤250V		
	Xe (57.9)							
	Xe (56.2)					<b>Worst-Case SEGR</b>		
	Xe (53.7)					SEGR		
	Xe (50.3)					SEB & SEGR Immuned @ VDS≤250V		

**Note:** “Qualified” indicates part is qualified by extension of insitu bias testing at higher VGS level. See [Concluding Tutorial](#) for more details.

**Table 4 Run Number Index**

Device Type / Part Number	Wafer Lot Number	Ion Beam Conditions			Run Date	Run Number
		Ion (LET)	Surface Energy	Range		
<b>IRH672x4</b> (R6, 250Volts, N-channel)	ER51915A	Xe (59)	823MeV	66μm	04-30-2005	001 to 024
		Ag (43)	1217MeV	112μm	04-30-2005	152 to 177
		Au (90)	1480MeV	80μm	04-30-2005	371 to 376
<b>Worst-Case Beam Condition Characterization</b>	ER54738	Xe (60.0)	683MeV	56μm	08-23-2005	237 to 241
	ER54738	Xe (57.9)	915MeV	73μm	08-23-2005	237 to 241
	ER54738	Xe (56.2)	1062MeV	84μm	08-23-2005	237 to 241
	ER54738	Xe (53.7)	1278MeV	101μm	08-23-2005	242 to 263

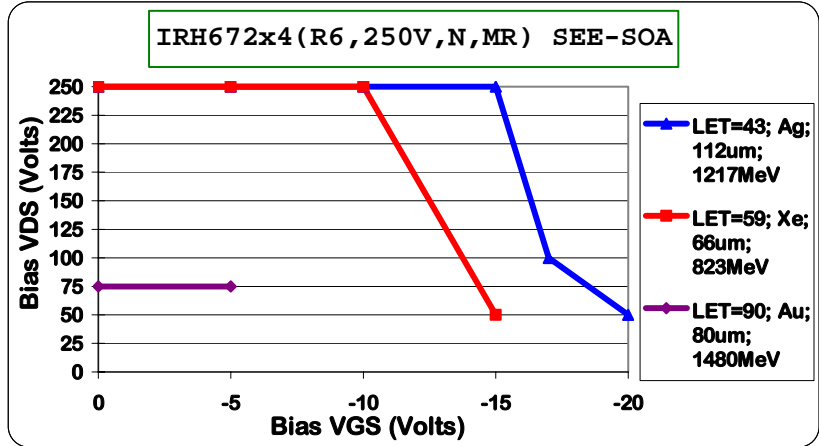
Figure 1 Device Safe Operating Area

IRH67264  
 VGS Bias

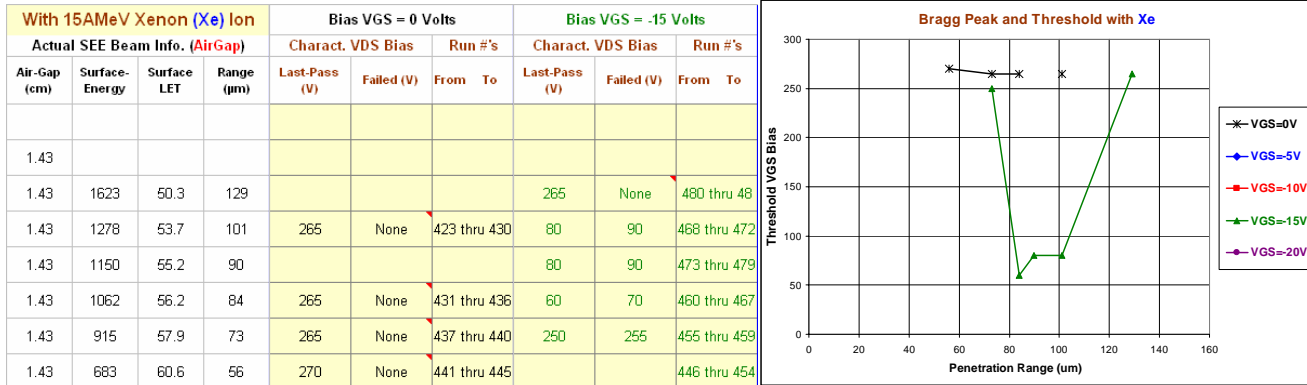
	LET=43; Ag; 112um; 1217MeV	LET=59; Xe; 66um; 823MeV	LET=90; Au; 80um; 1480MeV
0	250	250	75
-5	250	250	75
-10	250	250	
-15	250	50	
-17	100		
-20	50		

ER51915, Split A  
 4/30/2005

	Ag @ 15A MeV	Xe @ 15A MeV	Au @ 15A MeV



Wafer Lot ER54738 for worst-case beam-condition Evaluation (08/23/2005):



CONCLUSION

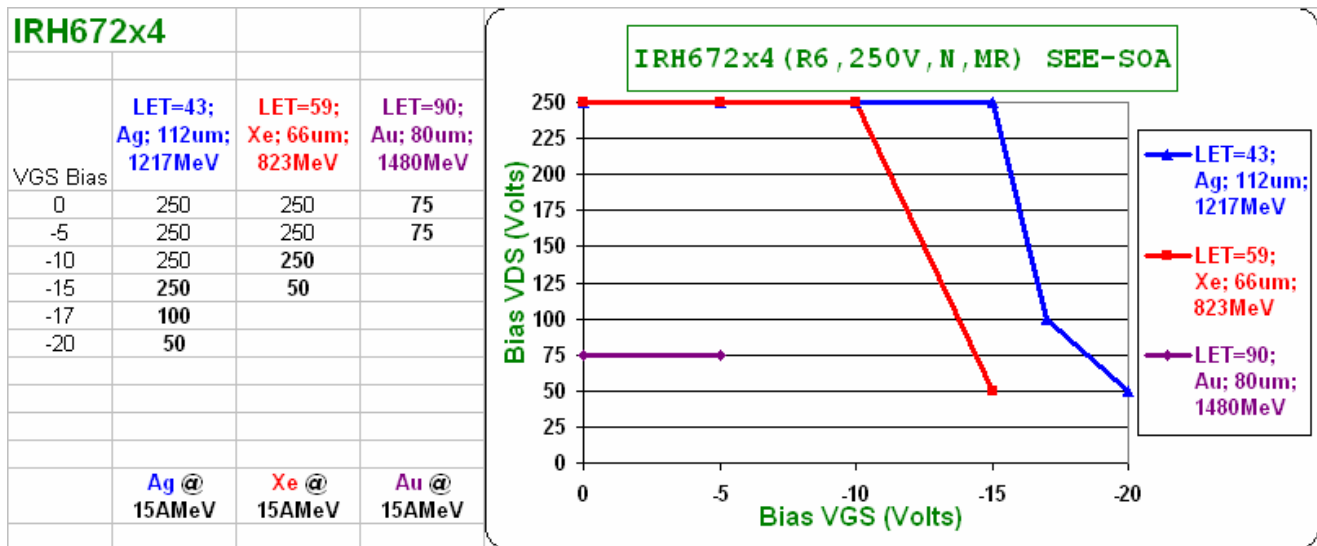
From worst-case beam-condition Evaluations, the 250-Volt N-Channel Dual-Epi R6 (IRHC672x4) is SEB-immune (regardless of Bragg Peak position) and SEGR-worst under  $V_{GS}=-15V$  with Bragg Peak near buffer-substrate interface.

For a final SEE Specification, the SEE Results from all three wafer lots are combined as worst-case result and listed below in both tabular and graphic SEE Safe-Operating-Area. The 250-Volt N-Channel Dual-Epi R6 (IRHC672x4) is SEE-hard at 100% Rated  $V_{DS}$  against the charged Silver (Ag) ion (LET=43) with -15V  $V_{GS}$  applied and against Xenon (Xe) ion (LET=59) with -10V  $V_{GS}$  applied.

**FINAL Single-Event-Effect Safe Operating Area (Tabular)**

Device Type Part Number	Ion (LET)	Energy	Range	$V_{GS}=0V$	$V_{GS}=-5V$	$V_{GS}=-10V$	$V_{GS}=-15V$	$V_{GS}=-17V$	$V_{GS}=-20V$
<b>IRH672x4</b> (R6, 250Volts, N-Channel)	Ag (43)	1217 MeV	112 $\mu m$	<i>Qualified</i>	<i>Qualified</i>	<i>Qualified</i>	250 V	100 V	50 V
	Xe (59)	823 MeV	66 $\mu m$	<i>Qualified</i>	<i>Qualified</i>	250 V	50 V		
	Au (90)	1480 MeV	80 $\mu m$	75 V	75 V				

**FINAL Single-Event-Effect Safe Operating Area (Graph)**



## CONCLUDING TUTORIAL

The following is presented to help the reader understand the basis on which SEE Testing is extended to the other part numbers.

### Extending Single Event Effects Testing

International Rectifier has designed Single Event Effects (SEE) experiments to maximize facility usage using four, industry accepted, assumptions as follows:

- I. Test results for one die size are representative of other die sizes, if the process and design rules are not changed. In other words the scaling of die size has no affect if all other variables are held constant. Please note that for a given voltage and technology, there are no differences in design and process for the various sizes of IR's radiation hardened MOSFET die, thus the assumption is valid. In reality, IR will always test the largest available die size. We consider this a worst-case scenario. The industry standard for acceptance of a given in-situ bias condition, is the acceptable performance of three or more devices at the specified conditions. Presently a supplier could achieve this standard with size 1 die thru size 6 die. We believe that use of the smaller die reduces the probability of failure, and thus reduces the chance of a SEE problem being discovered. The size 1 die are about one-twelfth the size of the size 6 die. Thus successfully testing three size 6 die is roughly equivalent to testing 36 size 1 die. This results in a savings of valuable test time at the SEE test facility, without degrading the final test result.
- II. Acceptable test results taken at given VGS and VDS conditions are applicable to lower VGS and VDS conditions. In other words an acceptable test result ( $\geq 3$  devices passing) at VGS = -15V and VDS = 200V, would also apply to VGS = -10, -5 or 0V at the same or lower VDS condition. In several cases parts have been tested at the worst-case in-situ bias condition of VGS = -20V and VDS = max rated BVDSS. With acceptable test results, the safe operation area, has been extended from VGS = 0 to -20V and VDS from 0 to the max rating. It is not necessary to verify every point below the accepted in-situ bias conditions. Again this saves valuable experiment time.
- III. Acceptable test results taken with a given LET, would also apply at other lower LETs. It is generally accepted that successful test results with Iodine, for example, implies the device would be hard against Bromine, Krypton, Nickel, etc., ion species with a lower LET. It is not necessary to test at each lower LET, again saving valuable test time.
- IV. The package used has no effect on the SEE hardness of a die. The die are characterized fully exposed to the ion beam. In other words the lid of the package is removed making the die visible. This removes the package as a variable when comparing test results. As a rule IR uses the common TO3 package for mounting die for SEE tests.

Each of the assumptions above is generally accepted within the industry. IR has verified their validity over the last several years and makes appropriate use of them to maximize the benefit for our customers.



# Appendix A

## Log Sheets

(SEE Run Data)

Test	SEE	Run	Ion	LET	Energy	Range	Flux	Fluence	Angle	BeamDia.	Vacuum	Device	S/N	Socket	VGS	VDS	Pass/Fail
Date	Facility	#		MeV.cm <sup>2</sup> /mg	MeV	µm	#/cm <sup>2</sup> /sec	#/cm <sup>2</sup>	deg	cm.	or Air?	Type		#	Volts	Volts	Blank=Pass
<b>250V, N, MR, R6 to Xenon (with LET=59)</b>																	
4/30/2005	TAMU	1	Xe	59	823	66	1.44E+04	3.00E+05	0	Split A	Vacuum	IRH67264	A1	1	-5	100	
4/30/2005	TAMU	2	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A1	1	-5	150	
4/30/2005	TAMU	3	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A1	1	-5	250	
4/30/2005	TAMU	4	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A1	1	-10	250	
4/30/2005	TAMU	5	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A1	1	-15	50	
4/30/2005	TAMU	6	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A1	1	-15	60	F Failed Blown
4/30/2005	TAMU	7	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A2	3	-10	250	Curve-Point
4/30/2005	TAMU	8	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A3	4	-10	250	Curve-Point
4/30/2005	TAMU	9	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A4	5	-10	250	F Gate Stress @ -20V
4/30/2005	TAMU	10	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A5	6	-10	250	Curve-Point
4/30/2005	TAMU	11	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A6	7	-10	250	Curve-Point +
4/30/2005	TAMU	12	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A7	8	-10	250	Curve-Point +
4/30/2005	TAMU	13	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A8	9	-10	250	Curve-Point +
4/30/2005	TAMU	14	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A9	10	-10	250	Curve-Point +
4/30/2005	TAMU	15	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A10	11	-10	250	Curve-Point +
4/30/2005	TAMU	16	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A11	12	-10	250	Curve-Point +
4/30/2005	TAMU	17	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A12	13	-10	250	Curve-Point +
4/30/2005	TAMU	18	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A14	15	-10	250	Curve-Point +
4/30/2005	TAMU	19	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A15	16	-10	250	Curve-Point +
4/30/2005	TAMU	20	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A16	17	-10	250	Curve-Point +
4/30/2005	TAMU	21	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A17	18	-10	250	Curve-Point +
4/30/2005	TAMU	22	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A6	7	-15	50	Curve-Point
4/30/2005	TAMU	23	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A7	8	-15	50	Curve-Point
4/30/2005	TAMU	24	Xe	59	823	66	1.44E+04	3.00E+05	0		Vacuum	IRH67264	A8	9	-15	50	Curve-Point
<b>250V, N, MR, R6 to Silver Ag (with LET=43)</b>																	
4/30/2005	TAMU	152	Ag	43	1217	112	2.70E+04	3.02E+05	0	Split A	Vacuum	IRH67264	A18	1	-10	250	
4/30/2005	TAMU	153	Ag	43	1217	112	2.68E+04	3.07E+05	0		Vacuum	IRH67264	A18	1	-15	150	
4/30/2005	TAMU	154	Ag	43	1217	112	2.96E+04	3.07E+05	0		Vacuum	IRH67264	A18	1	-15	175	
4/30/2005	TAMU	155	Ag	43	1217	112	2.74E+04	2.86E+05	0		Vacuum	IRH67264	A18	1	-15	200	
4/30/2005	TAMU	156	Ag	43	1217	112	3.00E+04	3.06E+05	0		Vacuum	IRH67264	A18	1	-15	225	
4/30/2005	TAMU	157	Ag	43	1217	112	2.77E+04	2.97E+05	0		Vacuum	IRH67264	A18	1	-15	250	Curve-Point
4/30/2005	TAMU	158	Ag	43	1217	112	2.85E+04	3.04E+05	0		Vacuum	IRH67264	A19	3	-15	250	Curve-Point
4/30/2005	TAMU	159	Ag	43	1217	112	2.62E+04	3.11E+05	0		Vacuum	IRH67264	A20	4	-15	250	Curve-Point
4/30/2005	TAMU	160	Ag	43	1217	112	2.68E+04	3.07E+05	0		Vacuum	IRH67264	A21	5	-20	50	
4/30/2005	TAMU	161	Ag	43	1217	112	2.51E+04	2.10E+05	0		Vacuum	IRH67264	A21	5	-20	75	F Failed Blown
4/30/2005	TAMU	162	Ag	43	1217	112	2.72E+04	3.06E+05	0		Vacuum	IRH67264	A22	6	-20	50	Curve-Point
4/30/2005	TAMU	163	Ag	43	1217	112	2.68E+04	2.95E+05	0		Vacuum	IRH67264	A23	7	-20	50	Curve-Point
4/30/2005	TAMU	164	Ag	43	1217	112	2.69E+04	3.08E+05	0		Vacuum	IRH67264	A24	8	-20	50	Curve-Point
4/30/2005	TAMU	165	Ag	43	1217	112	2.69E+04	3.11E+05	0		Vacuum	IRH67264	A25	9	-17	50	
4/30/2005	TAMU	166	Ag	43	1217	112	2.48E+04	3.10E+05	0		Vacuum	IRH67264	A25	9	-17	75	
4/30/2005	TAMU	167	Ag	43	1217	112	2.55E+04	3.02E+05	0		Vacuum	IRH67264	A25	9	-17	100	
4/30/2005	TAMU	168	Ag	43	1217	112	2.61E+04	3.11E+05	0		Vacuum	IRH67264	A25	9	-17	125	
4/30/2005	TAMU	169	Ag	43	1217	112	2.67E+04	3.02E+05	0		Vacuum	IRH67264	A25	9	-17	150	
4/30/2005	TAMU	170	Ag	43	1217	112	2.30E+04	3.09E+05	0		Vacuum	IRH67264	A25	9	-17	175	
4/30/2005	TAMU	171	Ag	43	1217	112	2.41E+04	1.47E+05	0		Vacuum	IRH67264	A25	9	-17	200	F Failed Blown

Test	SEE	Run	Ion	LET	Energy	Range	Flux	Fluence	Angle	BeamDia.	Vacuum	Device	S/N	Socket	VGS	VDS	Pass/Fail
Date	Facility	#		MeV.cm <sup>2</sup> /mg	MeV	μm	#/cm <sup>2</sup> /sec	#/cm <sup>2</sup>	deg	cm.	or Air?	Type		#	Volts	Volts	Blank=Pass
<b>250V, N, MR, R6 to Silver Ag (with LET=43)</b>																	
4/30/2005	TAMU	172	Ag	43	1217	112	2.42E+04	1.77E+05	0	Split A	Vacuum	IRH67264	A26	10	-17	175	F Failed Blown
4/30/2005	TAMU	173	Ag	43	1217	112	2.63E+04	2.88E+05	0		Vacuum	IRH67264	A27	11	-17	150	Curve-Point
4/30/2005	TAMU	174	Ag	43	1217	112	2.63E+04	3.02E+05	0		Vacuum	IRH67264	A28	12	-17	150	Curve-Point
4/30/2005	TAMU	175	Ag	43	1217	112	2.58E+04	1.41E+05	0		Vacuum	IRH67264	A29	13	-17	150	F Failed Blown
4/30/2005	TAMU	176	Ag	43	1217	112	3.68E+04	1.77E+05	0		Vacuum	IRH67264	A30	15	-17	125	F Failed: SEGR
4/30/2005	TAMU	177	Ag	43	1217	112	3.92E+04	3.05E+05	0		Vacuum	IRH67264	A31	16	-17	100	Curve-Point
<b>250V, N, MR, R6 to Gold Au (with LET=90)</b>																	
4/30/2005	TAMU	371	Au	90	1480	80	2.24E+04	3.09E+05	0	Split A	Vacuum	IRH67264	A34	1	-5	50	
4/30/2005	TAMU	372	Au	90	1480	80	2.15E+04	2.98E+05	0		Vacuum	IRH67264	A34	1	-5	75	
4/30/2005	TAMU	373	Au	90	1480	80	2.11E+04	2.16E+05	0		Vacuum	IRH67264	A34	1	-5	100	F PC Data: 1μA IDS Glitc
4/30/2005	TAMU	374	Au	90	1480	80	2.13E+04	3.02E+05	0		Vacuum	IRH67264	A35	3	-5	75	Curve-Point
4/30/2005	TAMU	375	Au	90	1480	80	2.10E+04	2.99E+05	0		Vacuum	IRH67264	A36	4	-5	75	Curve-Point
4/30/2005	TAMU	376	Au	90	1480	80	2.09E+04	3.03E+05	0		Vacuum	IRH67264	A37	5	-5	75	Curve-Point

Test	SEE	Run	Ion	LET	Energy	Range	Flux	Fluence	Angle	BeamDia.	Vacuum	Device	S/N	Socket	VGS	VDS	Pass/Fail
Date	Facility	#		MeV.cm <sup>2</sup> /mg	MeV	μm	#/cm <sup>2</sup> /sec	#/cm <sup>2</sup>	deg	cm.	or Air	Type		#	Volts	Volts	Blank=Pass
<b>250V, N, MR, R6 to Xenon (with LET=53.7)</b>																	
Beam Bragg Peak at Upper Buffer											WL# ER54738		SEB Evaluation				
8/24/2005	TAMU	423	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	200	
8/24/2005	TAMU	424	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	210	
8/24/2005	TAMU	425	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	220	
8/24/2005	TAMU	426	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	230	
8/24/2005	TAMU	427	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	240	
8/24/2005	TAMU	428	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	250	
8/24/2005	TAMU	429	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	260	
8/24/2005	TAMU	430	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	0	265	Reached BVDSS
<b>250V, N, MR, R6 to Xenon (with LET=56.0)</b>																	
Beam Bragg Peak at Middle of First Epi Layer											WL# ER54738		SEB Evaluation				
8/24/2005	TAMU	431	Xe	56.0	1062	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	0	220	
8/24/2005	TAMU	432	Xe	56.0	1062	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	0	230	
8/24/2005	TAMU	433	Xe	56.0	1062	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	0	240	
8/24/2005	TAMU	434	Xe	56.0	1062	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	0	250	
8/24/2005	TAMU	435	Xe	56.0	1062	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	0	260	
8/24/2005	TAMU	436	Xe	56.0	1062	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	0	265	Reached BVDSS
<b>250V, N, MR, R6 to Xenon (with LET=57.9)</b>																	
Beam Bragg Peak at between First Epi Layer and Buffer											WL# ER54738		SEB Evaluation				
8/24/2005	TAMU	437	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	0	240	
8/24/2005	TAMU	438	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	0	250	
8/24/2005	TAMU	439	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	0	260	
8/24/2005	TAMU	440	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	0	265	Reached BVDSS
<b>250V, N, MR, R6 to Xenon (with LET=60.6)</b>																	
Beam Bragg Peak at Junction											WL# ER54738		SEB Evaluation				
8/24/2005	TAMU	441	Xe	60.6	683	56	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	0	240	
8/24/2005	TAMU	442	Xe	60.6	683	56	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	0	250	
8/24/2005	TAMU	443	Xe	60.6	683	56	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	0	260	
8/24/2005	TAMU	444	Xe	60.6	683	56	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	0	265	
8/24/2005	TAMU	445	Xe	60.6	683	56	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	0	270	Reached BVDSS
<b>250V, N, MR, R6 to Xenon (with LET=50.3)</b>																	
Beam Bragg Peak at Middle of Buffer											WL# ER54738		SEGR Evaluation				
8/24/2005	TAMU	446	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	150	
8/24/2005	TAMU	447	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	170	
8/24/2005	TAMU	448	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	190	
8/24/2005	TAMU	449	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	210	
8/24/2005	TAMU	450	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	230	
8/24/2005	TAMU	451	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	240	
8/24/2005	TAMU	452	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	250	
8/24/2005	TAMU	453	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	260	
8/24/2005	TAMU	454	Xe	50.3	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C5	14	-15	265	Reached BVDSS
<b>250V, N, MR, R6 to Xenon (with LET=57.9)</b>																	
Beam Bragg Peak at between First Epi Layer and Buffer											WL# ER54738		SEGR Evaluation				
8/24/2005	TAMU	455	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C6	15	-15	200	
8/24/2005	TAMU	456	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C6	15	-15	220	
8/24/2005	TAMU	457	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C6	15	-15	240	
8/24/2005	TAMU	458	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C6	15	-15	250	High IGSS
8/24/2005	TAMU	459	Xe	57.9	915	73	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C6	15	-15	255	Failed
<b>250V, N, MR, R6 to Xenon (with LET=56.0)</b>																	
Beam Bragg Peak at Middle of First Epi Layer											WL# ER54738		SEGR Evaluation				
8/24/2005	TAMU	460	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C7	16	-15	220	Failed
8/24/2005	TAMU	461	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C8	17	-15	160	Failed
8/24/2005	TAMU	462	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C9	18	-15	50	

Test	SEE	Run	Ion	LET	Energy	Range	Flux	Fluence	Angle	BeamDia.	Vacuum	Device	S/N	Socket	VGS	VDS	Pass/Fail
Date	Facility	#		MeV.cm <sup>2</sup> /mg	MeV	µm	#/cm <sup>2</sup> /sec	#/cm <sup>2</sup>	deg	cm.	or Air	Type		#	Volts	Volts	Blank=Pass
<b>250V, N, MR, R6 to Xenon (with LET=56.0)</b>				<b>Beam Bragg Peak at Middle of First Epi Layer</b>							<b>WL# ER54738</b>			<b>SEGR Evaluation</b>			
8/24/2005	TAMU	463	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C9	18	-15	70	
8/24/2005	TAMU	464	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C9	18	-15	90	Failed
8/24/2005	TAMU	465	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	-15	50	
8/24/2005	TAMU	466	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	-15	60	
8/24/2005	TAMU	467	Xe	56.2	1052	84	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C1	10	-15	70	Failed
<b>250V, N, MR, R6 to Xenon (with LET=53.7)</b>				<b>Beam Bragg Peak at Upper Buffer</b>							<b>WL# ER54738</b>			<b>SEGR Evaluation</b>			
8/24/2005	TAMU	468	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	-15	50	
8/24/2005	TAMU	469	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	-15	60	
8/24/2005	TAMU	470	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	-15	70	
8/24/2005	TAMU	471	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	-15	80	
8/24/2005	TAMU	472	Xe	53.7	1278	101	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C2	11	-15	90	Failed
<b>250V, N, MR, R6 to Xenon (with LET=53.7)</b>				<b>Beam Bragg Peak at between Buffer and Substrate</b>							<b>WL# ER54738</b>			<b>SEGR Evaluation</b>			
8/24/2005	TAMU	473	Xe	55.2	1150	90	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	-15	30	
8/24/2005	TAMU	474	Xe	55.2	1150	90	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	-15	40	
8/24/2005	TAMU	475	Xe	55.2	1150	90	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	-15	50	
8/24/2005	TAMU	476	Xe	55.2	1150	90	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	-15	60	
8/24/2005	TAMU	477	Xe	55.2	1150	90	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	-15	70	
8/24/2005	TAMU	478	Xe	55.2	1150	90	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	-15	80	
8/24/2005	TAMU	479	Xe	55.2	1150	90	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C3	12	-15	90	Failed
<b>250V, N, MR, R6 to Xenon (with LET=50.0)</b>				<b>Beam Bragg Peak at Middle of Buffer</b>							<b>WL# ER54738</b>			<b>SEGR Evaluation</b>			
8/24/2005	TAMU	480	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	60	
8/24/2005	TAMU	481	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	70	
8/24/2005	TAMU	482	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	80	
8/24/2005	TAMU	483	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	90	
8/24/2005	TAMU	484	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	100	
8/24/2005	TAMU	485	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	110	
8/24/2005	TAMU	486	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	120	
8/24/2005	TAMU	487	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	130	
8/24/2005	TAMU	488	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	140	
8/24/2005	TAMU	489	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	150	
8/24/2005	TAMU	490	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	160	
8/24/2005	TAMU	491	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	170	
8/24/2005	TAMU	492	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	180	
8/24/2005	TAMU	493	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	190	
8/24/2005	TAMU	494	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	210	
8/24/2005	TAMU	495	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	230	
8/24/2005	TAMU	496	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	250	
8/24/2005	TAMU	497	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	255	
8/24/2005	TAMU	498	Xe	50.0	1623	129	1.00E+04	3.00E+05	0	1.5	Air	IRH67264	C4	13	-15	265	

# Appendix B

## TAMU Cyclotron Institute

### Facility Beam Data & Graphs

R6, 250V  
SEE Test Report  
September 2005 – TAMU Cyclotron



Cyclotron Institute Texas A&M University - Radiation Testing Report  
File: IR0405

(V. Horvat 00/06/13)

Compiled on 05/05/01 at 07:19:02

Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV.cm2/mg	Range µm	<Flux> #/cm2/sec	Fluence #/cm2	Dose RAD(S)	E-fluence RAD(S)	%err	Al(um)	USD	Live	Dead	BID	Gain	Unif	Shft	E-LET	E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments
1	I00	11082	11:55	Xe	15	823	59	66	14400	301000	284	301000	0.126	82	OUT	21	0	19	1.75	82	14	59	66	imosfet	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
2	I01	11082	12:01	Xe	15	823	59	66	14100	293000	277	293000	0.128	82	OUT	21	0	19	1.12	96	3	59	66	imosfet	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
3	I02	11082	12:02	Xe	15	823	59	66	13300	295000	279	295000	0.124	82	OUT	22	0	19	1.07	95	3	59	66	imosfet	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
4	I03	11082	12:03	Xe	15	823	59	66	13800	306000	290	306000	0.121	82	OUT	22	0	19	1.1	95	3	59	66	imosfet	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
5	I04	11082	12:05	Xe	15	823	59	66	14100	295000	279	295000	0.127	82	OUT	21	0	19	1.12	97	2	59	66	imosfet	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
6	I05	11082	12:05	Xe	15	823	59	66	14100	55400	52.4	55400	0.679	82	OUT	4	0	19	1.12	95	3	59	66	imosfet	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
7	I06	11082	12:18	Xe	15	823	59	66	14200	300000	283	300000	0.126	82	OUT	21	0	19	1.15	96	2	59	66	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
8	I07	11082	12:19	Xe	15	823	59	66	14300	296000	279	296000	0.128	82	OUT	21	0	19	1.15	96	2	59	66	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
9	I08	11082	12:19	Xe	15	823	59	66	14500	293000	277	293000	0.130	82	OUT	20	0	19	1.15	96	2	59	66	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
10	I09	11082	12:23	Xe	15	823	59	66	14100	298000	282	298000	0.126	82	OUT	21	0	19	1.15	95	3	59	66	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
11	I0A	11082	12:25	Xe	15	823	59	66	14000	295000	279	295000	0.127	82	OUT	21	0	19	1.15	96	3	59	66	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
12	I0B	11082	12:26	Xe	15	823	59	66	13700	295000	279	295000	0.125	82	OUT	22	0	19	1.15	95	3	59	66	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
13	I0C	11082	12:28	Xe	15	823	59	66	15500	303000	286	303000	0.130	82	OUT	19	0	19	1.32	95	3	59	66	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
14	I0D	11082	12:29	Xe	15	823	59	66	15500	296000	280	296000	0.133	82	OUT	19	0	19	1.32	96	3	59	66	Current	Current	0.673	-0.061	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
15	I0E	11082	12:30	Xe	15	823	59	66	14900	307000	290	307000	0.126	82	OUT	21	0	19	1.26	96	3	59	66	Current	Current	2.418	-0.06	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
16	I0F	11082	12:31	Xe	15	823	59	66	14800	303000	286	303000	0.127	82	OUT	21	0	19	1.26	95	3	59	66	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
17	I0G	11082	12:32	Xe	15	823	59	66	14900	304000	287	304000	0.127	82	OUT	20	0	19	1.22	96	3	59	66	Current	Current	-4.494	2.101	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
18	I0H	11082	12:33	Xe	15	823	59	66	14500	298000	282	298000	0.128	82	OUT	21	0	19	1.22	95	3	59	66	Current	Current	-1.108	2.142	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
19	I0I	11082	12:35	Xe	15	823	59	66	14600	303000	286	303000	0.126	82	OUT	21	0	19	1.22	95	3	59	66	Current	Current	0.673	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
20	I0J	11082	12:35	Xe	15	823	59	66	13300	301000	285	301000	0.121	82	OUT	23	0	19	1.22	96	3	59	66	Current	socket 1	2.691	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
21	I0K	11082	12:36	Xe	15	823	59	66	14700	304000	287	304000	0.126	82	OUT	21	0	19	1.22	96	3	59	66	Current	socket 1	4.397	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
22	I0L	11082	12:42	Xe	15	823	59	66	14100	303000	287	303000	0.124	82	OUT	21	0	19	1.19	96	2	59	66	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
23	I0M	11082	12:43	Xe	15	823	59	66	13900	303000	287	303000	0.123	82	OUT	22	0	19	1.19	96	2	59	66	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
24	I0N	11082	12:44	Xe	15	823	59	66	13900	297000	280	297000	0.126	82	OUT	21	0	19	1.19	96	3	59	66	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
25	I0O	11082	13:37	Xe	15	823	59	66	13500	300000	284	300000	0.122	82	OUT	22	0	19	1.17	94	4	59	66	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
26	I0P	11082	13:38	Xe	15	823	59	66	12600	59000	55.8	59000	0.602	82	OUT	5	0	19	1.09	94	4	59	66	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
27	I0Q	11082	13:42	Xe	15	823	59	66	12400	301000	284	301000	0.117	82	OUT	24	0	19	1.07	94	3	59	66	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
28	I0R	11082	13:43	Xe	15	823	59	66	12500	302000	286	302000	0.117	82	OUT	24	0	19	1.07	95	3	59	66	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
29	I0S	11082	13:44	Xe	15	823	59	66	12300	297000	281	297000	0.118	82	OUT	24	0	19	1.05	95	3	59	66	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
30	I0T	11082	13:45	Xe	15	823	59	66	12400	296000	280	296000	0.119	82	OUT	24	0	19	1.05	95	3	59	66	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
31	I0U	11082	13:46	Xe	15	823	59	66	11400	170000	160	170000	0.199	82	OUT	15	0	19	0.99	95	3	59	66	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
32	I0V	11082	13:47	Xe	15	823	59	66	12300	300000	284	300000	0.117	82	OUT	24	0	19	1.03	95	3	59	66	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
33	I0W	11082	13:48	Xe	15	823	59	66	11800	303000	286	303000	0.114	82	OUT	26	0	19	1	95	3	59	66	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
34	I0X	11082	13:49	Xe	15	823	59	66	11800	17200	163	17200	0.200	82	OUT	15	0	19	1	95	3	59	66	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
35	I0Y	11082	13:50	Xe	15	823	59	66	11800	300000	284	300000	0.114	82	OUT	25	0	19	1	95	3	59	66	Current	Current	-4.494	-0.102														



R6, 250V  
SEE Test Report  
September 2005 – TAMU Cyclotron



Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV.cm2/mg	Range μm	<Flux> #/cm2/sec	Fluence #/cm2	Dose RAD(S)	E-fluence RAD(S)	%err	Al(um)	USD	Live	Dead	BID	Gain	Unif	Shft	E-LET	E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments
76	I23	11082	16:12	Xe	15	823	59	66	11900	300000	283	300000	0.115	82	OUT	25	0	19	0.76	98	1	59	66	Current	Current	-4.94	2.101	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
77	I24	11082	16:13	Xe	15	823	59	66	12100	298000	282	298000	0.117	82	OUT	25	0	19	0.77	98	0	59	66	Current	Current	-4.94	2.101	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
78	I25	11082	16:14	Xe	15	823	59	66	11900	303000	287	303000	0.113	82	OUT	26	0	19	0.76	98	0	59	66	Current	Current	-4.94	2.101	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
79	I26	11082	16:15	Xe	15	823	59	66	11300	300000	284	300000	0.112	82	OUT	27	0	19	0.76	99	1	59	66	Current	Current	-4.94	2.101	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
80	I27	11082	16:16	Xe	15	823	59	66	11700	303000	287	303000	0.113	82	OUT	26	0	19	0.76	99	0	59	66	Current	Current	-4.94	2.101	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
81	I28	11082	16:21	Xe	15	823	59	66	11500	97200	91.9	97200	0.350	82	OUT	8	0	19	0.76	99	0	59	66	Current	Current	-1.108	2.142	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
82	I29	11082	16:22	Xe	15	823	59	66	10400	302000	285	302000	0.107	82	OUT	29	0	19	0.76	98	1	59	66	Current	Current	0.673	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
83	I2A	11082	16:23	Xe	15	823	59	66	10100	301000	284	301000	0.106	82	OUT	30	0	19	0.73	98	1	59	66	Current	Current	0.673	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
84	I2B	11082	16:25	Xe	15	823	59	66	9860	297000	280	297000	0.106	82	OUT	30	0	19	0.73	99	0	59	66	Current	socket 1	2.691	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
85	I2C	11082	16:26	Xe	15	823	59	66	9770	295000	279	295000	0.106	82	OUT	30	0	19	0.73	99	1	59	66	Current	socket 1	2.691	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
86	I2D	11082	18:31	Xe	15	823	59	66	10600	301000	285	301000	0.108	82	OUT	28	0	19	0.74	98	0	59	66	Current	socket 1	4.397	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
87	I2E	11082	18:32	Xe	15	823	59	66	10600	301000	284	301000	0.108	82	OUT	28	0	19	0.75	98	1	59	66	Current	socket 1	4.397	2.144	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
88	I2F	11082	18:09	Xe	15	823	59	66	10400	296000	279	296000	0.109	82	OUT	29	0	19	0.85	86	2	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
89	I2G	11082	18:10	Xe	15	823	59	66	10300	296000	280	296000	0.108	82	OUT	29	0	19	0.84	85	2	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
90	I2H	11082	18:11	Xe	15	823	59	66	10200	298000	282	298000	0.107	82	OUT	29	0	19	0.84	86	2	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
91	I2I	11082	18:12	Xe	15	823	59	66	9660	43100	40.8	43100	0.720	82	OUT	4	0	19	0.79	86	1	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
92	I2J	11082	18:13	Xe	15	823	59	66	9280	300000	283	300000	0.102	82	OUT	32	0	19	0.77	85	2	59	66	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
93	I2K	11082	18:14	Xe	15	823	59	66	9830	296000	280	296000	0.106	82	OUT	30	0	19	0.82	86	1	59	66	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
94	I2L	11082	18:16	Xe	15	823	59	66	9550	295000	279	295000	0.105	82	OUT	31	0	19	0.84	86	1	59	66	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
95	I2M	11082	18:19	Xe	15	823	59	66	10000	122000	116	122000	0.259	82	OUT	12	0	19	0.82	85	2	59	66	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
96	I2N	11082	18:20	Xe	15	823	59	66	10600	303000	286	303000	0.108	82	OUT	28	0	19	0.76	86	1	59	66	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
97	I2O	11082	18:21	Xe	15	823	59	66	11200	303000	286	303000	0.111	82	OUT	27	0	19	0.82	86	1	59	66	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
98	I2P	11082	18:22	Xe	15	823	59	66	11200	295000	279	295000	0.113	82	OUT	26	0	19	0.82	86	2	59	66	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
99	I2Q	11082	18:23	Xe	15	823	59	66	10300	297000	281	297000	0.108	82	OUT	29	0	19	0.81	85	2	59	66	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
100	I2R	11082	18:25	Xe	15	823	59	66	11300	302000	285	302000	0.111	82	OUT	27	0	19	0.81	86	1	59	66	Current	Current	-4.94	-0.102	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
101	I2S	11082	18:26	Xe	15	823	59	66	12100	297000	281	297000	0.117	82	OUT	24	0	19	0.89	86	1	59	66	Current	Current	-4.94	-0.102	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
102	I2T	11082	18:32	Xe	15	823	59	66	10500	297000	281	297000	0.111	82	OUT	27	0	19	0.81	86	1	59	66	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
103	I2U	11082	18:33	Xe	15	823	59	66	10700	300000	284	300000	0.109	82	OUT	28	0	19	0.81	85	2	59	66	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
104	I2V	11082	18:35	Xe	15	823	59	66	11000	305000	289	305000	0.108	82	OUT	28	0	19	0.83	85	2	59	66	Current	Current	-4.94	-0.102	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
105	I2W	11082	19:46	Xe	15	823	59	66	9810	301000	284	301000	0.104	82	OUT	31	0	19	0.68	86	1	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
106	I2X	11082	19:47	Xe	15	823	59	66	9800	302000	285	302000	0.104	82	OUT	31	0	19	0.68	86	2	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
107	I2Y	11082	19:48	Xe	15	823	59	66	9990	296000	280	296000	0.107	82	OUT	30	0	19	0.7	86	2	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
108	I2Z	11082	19:49	Xe	15	823	59	66	10600	285000	270	285000	0.114	82	OUT	27	0	19	0.75	86	2	59	66	Current	Current	-4.94	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
109	I30	11082	19:51	Xe	15	823	59	66	8970	299000	283	299000	0.100	82	OUT	33	0	19	0.63	86	2	59	66	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
110	I31	11082	19:52	Xe	15	823	59	66	9980	302000	286	302000	0.104	82	OUT	30	0	19	0.7	86	2	59	66	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	51.538	2	290	290	310	300	370	0	Nolayers.lay	None.
111	I32	11082	19:54	Xe																																					



Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV.cm2/mg	Range µm	<Flux> #/cm2/sec	Fluence #/cm2	Dose RAD(S)	E-fluon RAD(S)	%err	Al(um)	USD	Live	Dead	BID	Gain	Unif	Shft	E-LET	E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments
154	149	11082	23:28	Ag	15	1217	43	112	29600	307000	211	306000	0.178	40	OUT	10	0	18	0.66	91	6	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
155	14A	11082	23:28	Ag	15	1217	43	112	27400	286000	197	286000	0.183	40	OUT	10	0	18	0.63	92	5	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
156	14B	11082	23:29	Ag	15	1217	43	112	30000	306000	211	306000	0.179	40	OUT	10	0	18	0.66	91	6	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
157	14C	11082	23:30	Ag	15	1217	43	112	27700	297000	204	297000	0.178	40	OUT	11	0	18	0.61	89	7	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
158	14D	11082	23:31	Ag	15	1217	43	112	28500	304000	210	304000	0.175	40	OUT	11	0	18	0.62	90	6	43	112	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
159	14E	11082	23:32	Ag	15	1217	43	112	26200	311000	214	311000	0.164	40	OUT	12	0	18	0.59	90	6	43	112	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
160	14F	11082	23:33	Ag	15	1217	43	112	26800	307000	212	307000	0.168	40	OUT	11	0	18	0.59	91	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
161	14G	11082	23:34	Ag	15	1217	43	112	25100	210000	145	210000	0.239	40	OUT	8	0	18	0.55	90	7	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
162	14H	11082	23:34	Ag	15	1217	43	112	27200	306000	211	306000	0.170	40	OUT	11	0	18	0.6	91	6	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
163	14I	11082	23:35	Ag	15	1217	43	112	26800	295000	203	295000	0.175	40	OUT	11	0	18	0.6	91	6	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
164	14J	11082	23:36	Ag	15	1217	43	112	26900	308000	212	308000	0.168	40	OUT	11	0	18	0.6	91	6	43	112	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
165	14K	11082	23:37	Ag	15	1217	43	112	26900	311000	214	311000	0.167	40	OUT	12	0	18	0.59	91	6	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
166	14L	11082	23:37	Ag	15	1217	43	112	24800	310000	214	310000	0.160	40	OUT	13	0	18	0.54	90	6	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
167	14M	11082	23:38	Ag	15	1217	43	112	25500	302000	208	302000	0.167	40	OUT	12	0	18	0.56	90	7	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
168	14N	11082	23:38	Ag	15	1217	43	112	26100	311000	214	311000	0.165	40	OUT	12	0	18	0.58	89	7	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
169	14O	11082	23:39	Ag	15	1217	43	112	26700	302000	208	302000	0.171	40	OUT	11	0	18	0.59	90	7	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
170	14P	11082	23:39	Ag	15	1217	43	112	23000	309000	213	309000	0.155	40	OUT	13	0	18	0.51	89	7	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
171	14Q	11082	23:40	Ag	15	1217	43	112	24100	147000	101	147000	0.335	40	OUT	6	0	18	0.54	90	7	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
172	14R	11082	23:41	Ag	15	1217	43	112	24200	177000	122	177000	0.279	40	OUT	7	0	18	0.54	90	6	43	112	Current	Current	0.673	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
173	14S	11082	23:41	Ag	15	1217	43	112	26300	288000	198	288000	0.178	40	OUT	11	0	18	0.58	90	7	43	112	Current	Current	2.418	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
174	14T	11082	23:42	Ag	15	1217	43	112	26300	302000	208	302000	0.170	40	OUT	11	0	18	0.58	89	7	43	112	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
175	14U	11082	23:43	Ag	15	1217	43	112	25800	141000	97	141000	0.361	40	OUT	5	0	18	0.58	90	7	43	112	Current	Current	-4.494	2.101	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
176	14V	11082	23:44	Ag	15	1217	43	112	36800	177000	122	177000	0.343	40	OUT	5	0	18	0.99	90	6	43	112	Current	Current	-1.108	2.142	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
177	14W	11082	23:45	Ag	15	1217	43	112	39200	305000	210	305000	0.205	40	OUT	8	0	18	0.99	90	6	43	112	Current	Current	0.673	2.144	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
178	14X	37016	1:02	Ag	15	1217	43	112	25500	291000	200	291000	0.173	40	OUT	11	0	18	1.3	90	7	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
179	14Y	37016	1:03	Ag	15	1217	43	112	24600	302000	208	302000	0.164	40	OUT	12	0	18	1.26	90	7	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
180	14Z	37016	1:04	Ag	15	1217	43	112	25200	311000	214	311000	0.161	40	OUT	12	0	18	1.28	92	5	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
181	150	37016	1:04	Ag	15	1217	43	112	24400	291000	200	291000	0.170	40	OUT	12	0	18	1.28	92	5	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
182	151	37016	1:04	Ag	15	1217	43	112	24700	299000	206	299000	0.166	40	OUT	12	0	18	1.28	93	5	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
183	152	37016	1:05	Ag	15	1217	43	112	24400	289000	199	289000	0.171	40	OUT	12	0	18	1.29	92	5	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
184	153	37016	1:06	Ag	15	1217	43	112	24600	303000	209	303000	0.164	40	OUT	12	0	18	1.31	93	4	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
185	154	37016	1:07	Ag	15	1217	43	112	23600	305000	210	305000	0.160	40	OUT	13	0	18	1.24	90	7	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
186	155	37016	1:07	Ag	15	1217	43	112	23800	306000	211	306000	0.159	40	OUT	13	0	18	1.25	90	7	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
187	156	37016	1:08	Ag	15	1217	43	112	24600	302000	208	302000	0.164	40	OUT	12	0	18	1.25	90	7	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
188	157	37016	1:08	Ag	15	1217	43	112	23500	307000	211	307000	0.158	40	OUT	13	0	18	1.27	91	6	43	112	Current	Current	-4.494	-2.														

R6, 250V  
SEE Test Report  
September 2005 – TAMU Cyclotron



Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV.cm2/mg	Range µm	<Flux> #/cm2sec	Fluence #/cm2	Dose RAD(S)	E-Fluence RAD(S)	%err	Al(um)	USD	Live	Dead	BID	Gain	Unif	Shft	E-LET	E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments
231	6E	37016	1:43	Ag	15	1217	43	112	18700	297000	205	297000	0.146	40	OUT	16	0	18	1.28	91	6	43	112	Current	Current	2.691	2.144	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
232	6F	37016	1:44	Ag	15	1217	43	112	18700	260000	179	260000	0.166	40	OUT	14	0	18	1.28	92	5	43	112	Current	Current	4.397	2.144	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
233	6G	37016	2:20	Ag	15	1217	43	112	15600	300000	207	300000	0.132	40	OUT	19	0	18	1.34	90	6	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
234	6H	37016	2:21	Ag	15	1217	43	112	15400	303000	209	303000	0.129	40	OUT	20	0	18	1.26	92	5	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
235	6I	37016	2:21	Ag	15	1217	43	112	15900	296000	204	296000	0.135	40	OUT	19	0	18	1.27	93	4	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
236	6J	37016	2:22	Ag	15	1217	43	112	15600	309000	213	309000	0.128	40	OUT	20	0	18	1.25	93	4	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
237	6K	37016	2:23	Ag	15	1217	43	112	15200	110000	76.1	110000	0.353	40	OUT	7	0	18	1.25	91	6	43	112	Current	Current	-4.494	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
238	6L	37016	2:24	Ag	15	1217	43	112	14500	306000	211	306000	0.124	40	OUT	21	0	18	1.25	93	5	43	112	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
239	6M	37016	2:25	Ag	15	1217	43	112	14600	301000	207	301000	0.127	40	OUT	21	0	18	1.24	94	4	43	112	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
240	6N	37016	2:25	Ag	15	1217	43	112	14700	302000	208	302000	0.127	40	OUT	21	0	18	1.25	93	4	43	112	Current	Current	-1.108	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
241	6O	37016	2:26	Ag	15	1217	43	112	14900	297000	205	297000	0.130	40	OUT	20	0	18	1.25	93	4	43	112	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
242	6P	37016	2:27	Ag	15	1217	43	112	14800	294000	202	294000	0.131	40	OUT	20	0	18	1.24	94	4	43	112	Current	Current	0.673	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
243	6Q	37016	2:29	Ag	15	1217	43	112	14500	300000	207	300000	0.127	40	OUT	21	0	18	1.25	93	5	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
244	6R	37016	2:30	Ag	15	1217	43	112	14900	253000	174	253000	0.153	40	OUT	17	0	18	1.27	92	5	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
245	6S	37016	2:31	Ag	15	1217	43	112	14800	296000	204	296000	0.130	40	OUT	20	0	18	1.27	94	3	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
246	6T	37016	2:32	Ag	15	1217	43	112	14800	300000	207	300000	0.128	40	OUT	20	0	18	1.27	93	4	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
247	6U	37016	2:33	Ag	15	1217	43	112	14500	296000	204	296000	0.128	40	OUT	20	0	18	1.25	93	4	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
248	6V	37016	2:34	Ag	15	1217	43	112	14000	293000	202	293000	0.128	40	OUT	21	0	18	1.28	93	5	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
249	6W	37016	2:35	Ag	15	1217	43	112	14100	71700	49.4	71700	0.525	40	OUT	5	0	18	1.28	92	5	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
250	6X	37016	2:37	Ag	15	1217	43	112	14000	301000	207	301000	0.125	40	OUT	21	0	18	1.28	94	4	43	112	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
251	6Y	37016	2:38	Ag	15	1217	43	112	13900	301000	207	301000	0.124	40	OUT	22	0	18	1.27	94	4	43	112	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
252	6Z	37016	2:40	Ag	15	1217	43	112	13700	304000	209	304000	0.122	40	OUT	22	0	18	1.27	93	4	43	112	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
253	70	37016	2:45	Ag	15	1217	43	112	20800	291000	200	291000	0.157	40	OUT	14	0	18	1.31	95	3	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
254	71	37016	2:46	Ag	15	1217	43	112	20600	307000	211	307000	0.148	40	OUT	15	0	18	1.3	95	3	43	112	Current	Current	-1.108	-0.062	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
255	72	37016	2:47	Ag	15	1217	43	112	20000	295000	200	295000	0.154	40	OUT	15	0	18	1.3	94	3	43	112	Current	Current	0.673	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
256	73	37016	2:48	Ag	15	1217	43	112	17800	295000	203	295000	0.143	40	OUT	17	0	18	1.32	94	3	43	112	Current	Current	0.673	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
257	74	37016	2:49	Ag	15	1217	43	112	20400	301000	208	301000	0.150	40	OUT	15	0	18	1.32	94	3	43	112	Current	Current	2.418	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
258	75	37016	2:49	Ag	15	1217	43	112	20900	299000	206	299000	0.153	40	OUT	14	0	18	1.34	94	3	43	112	Current	Current	2.418	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
259	76	37016	2:51	Ag	15	1217	43	112	20600	297000	204	297000	0.153	40	OUT	14	0	18	1.34	95	3	43	112	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
260	77	37016	2:51	Ag	15	1217	43	112	20000	296000	204	296000	0.151	40	OUT	15	0	18	1.3	94	3	43	112	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
261	78	37016	2:53	Ag	15	1217	43	112	20300	292000	201	292000	0.154	40	OUT	14	0	18	1.3	94	4	43	112	Current	Current	-4.494	2.101	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
262	79	37016	2:53	Ag	15	1217	43	112	20700	308000	212	308000	0.148	40	OUT	15	0	18	1.34	94	4	43	112	Current	Current	-4.494	2.101	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
263	7A	37016	2:54	Ag	15	1217	43	112	20400	302000	208	302000	0.149	40	OUT	15	0	18	1.34	94	3	43	112	Current	Current	-1.108	2.142	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
264	7B	37016	2:58	Ag	15	1217	43	112	19800	308000	212	308000	0.145	40	OUT	16	0	18	1.33	94	3	43	112	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
265	7C	37016	3:00	Ag	15	1217	43	112	20300	304000	209	304000	0.148	40	OUT	15	0	18	1.33	93	4	43	112	Current	Current	0.673	2.144	0	0.502	0.886	0.737	50.225	1								

Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV.cm2/mg	Range µm	<Flux> #/cm2/sec	Fluence #/cm2	Dose RAD(S)	E-Fluence RAD(S)	%err	Al(um)	USD	Live	Dead	BID	Gain	Unif	Shft	E-LET	E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments
309	18K	37016	5:13	Ag	15	1217	43	112	19100	293000	202	293000	0.149	40	OUT	15	0	18	1.33	90	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
310	18L	37016	5:14	Ag	15	1217	43	112	19400	292000	201	292000	0.151	40	OUT	15	0	18	1.33	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
311	18M	37016	5:15	Ag	15	1217	43	112	19200	297000	205	297000	0.147	40	OUT	16	0	18	1.3	88	7	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
312	18N	37016	5:15	Ag	15	1217	43	112	19100	301000	208	301000	0.145	40	OUT	16	0	18	1.3	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
313	18O	37016	5:16	Ag	15	1217	43	112	19100	306000	211	306000	0.142	40	OUT	16	0	18	1.31	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
314	18P	37016	5:16	Ag	15	1217	43	112	19300	303000	209	303000	0.145	40	OUT	16	0	18	1.33	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
315	18Q	37016	5:17	Ag	15	1217	43	112	19400	306000	211	306000	0.144	40	OUT	16	0	18	1.33	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
316	18R	37016	5:17	Ag	15	1217	43	112	19700	308000	212	308000	0.144	40	OUT	16	0	18	1.32	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
317	18S	37016	5:18	Ag	15	1217	43	112	19200	301000	207	301000	0.146	40	OUT	16	0	18	1.32	89	7	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
318	18T	37016	5:18	Ag	15	1217	43	112	18500	308000	212	308000	0.140	40	OUT	17	0	18	1.3	90	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
319	18U	37016	5:19	Ag	15	1217	43	112	18400	304000	209	304000	0.141	40	OUT	17	0	18	1.3	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
320	18V	37016	5:19	Ag	15	1217	43	112	18400	298000	205	298000	0.144	40	OUT	16	0	18	1.29	89	6	43	112	Current	Current	2.418	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
321	18W	37016	5:20	Ag	15	1217	43	112	19200	308000	212	308000	0.142	40	OUT	16	0	18	1.33	89	7	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
322	18X	37016	5:21	Ag	15	1217	43	112	18900	292000	201	292000	0.149	40	OUT	15	0	18	1.31	90	6	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
323	18Y	37016	5:21	Ag	15	1217	43	112	18800	294000	203	294000	0.148	40	OUT	16	0	18	1.31	89	6	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
324	18Z	37016	5:22	Ag	15	1217	43	112	19400	301000	207	301000	0.147	40	OUT	16	0	18	1.34	88	7	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
325	190	37016	5:22	Ag	15	1217	43	112	18500	298000	206	298000	0.144	40	OUT	16	0	18	1.29	89	7	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
326	191	37016	5:23	Ag	15	1217	43	112	18100	53500	36.9	53500	0.796	40	OUT	3	0	18	1.29	90	6	43	112	Current	Current	4.154	-2.256	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
327	192	37016	5:24	Ag	15	1217	43	112	19100	300000	206	300000	0.146	40	OUT	16	0	18	1.31	88	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
328	193	37016	5:25	Ag	15	1217	43	112	19600	300000	207	300000	0.148	40	OUT	15	0	18	1.31	88	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
329	194	37016	5:25	Ag	15	1217	43	112	19000	295000	203	295000	0.148	40	OUT	16	0	18	1.29	88	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
330	195	37016	5:26	Ag	15	1217	43	112	19200	305000	210	305000	0.144	40	OUT	16	0	18	1.29	88	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
331	196	37016	5:26	Ag	15	1217	43	112	18900	293000	202	293000	0.148	40	OUT	16	0	18	1.3	88	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
332	197	37016	5:27	Ag	15	1217	43	112	19000	297000	205	297000	0.147	40	OUT	16	0	18	1.3	89	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
333	198	37016	5:27	Ag	15	1217	43	112	18700	295000	203	295000	0.147	40	OUT	16	0	18	1.29	90	6	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
334	199	37016	5:28	Ag	15	1217	43	112	18300	294000	203	294000	0.145	40	OUT	16	0	18	1.3	89	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
335	19A	37016	5:28	Ag	15	1217	43	112	19000	103000	70.9	103000	0.424	40	OUT	5	0	18	1.32	89	7	43	112	Current	Current	-4.494	-0.102	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
336	19B	37016	5:29	Ag	15	1217	43	112	19200	293000	202	293000	0.149	40	OUT	15	0	18	1.3	89	7	43	112	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
337	19C	37016	5:30	Ag	15	1217	43	112	18800	296000	204	296000	0.146	40	OUT	16	0	18	1.31	89	7	43	112	Current	Current	-2.859	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
338	19D	37016	5:35	Ag	15	1217	43	112	18400	307000	212	307000	0.139	40	OUT	17	0	18	1.31	88	7	43	112	Current	Current	0.673	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
339	19E	37016	5:35	Ag	15	1217	43	112	18000	42300	29.1	42300	1.000	40	OUT	2	0	18	1.31	88	7	43	112	Current	Current	0.673	-0.061	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
340	19F	37016	5:36	Ag	15	1217	43	112	18300	309000	213	309000	0.138	40	OUT	17	0	18	1.31	88	7	43	112	Current	Current	2.418	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
341	19G	37016	5:37	Ag	15	1217	43	112	17600	294000	202	294000	0.143	40	OUT	17	0	18	1.31	91	5	43	112	Current	Current	2.418	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
342	19H	37016	5:37	Ag	15	1217	43	112	18900	292000	201	292000	0.148	40	OUT	16	0	18	1.32	89	7	43	112	Current	Current	2.418	-0.06	0	0.502	0.886	0.737	50.225	1	254	262	285	266	334	0	Nolayers.lay	None.
343	19I	37016	5:38	Ag	15	1217	43	112	18300	298000	206	298000	0.143	40	OUT	16	0	18	1.33	89	6	43	112	Current	Current	2.418	-0.06	0	0.502	0.											

Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV.cm2/mg	Range μm	<Flux> #/cm2/sec	Fluence #/cm2	Dose RAD(S)	E-fluen RAD(S)	%err	Al(um)	USD	Live	Dead	BID	Gain	Unif	Shft	E-LET	E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments
386	tAP	37016	7:08	Au	15	1480	90	80	22100	305000	439	305000	0.154	67	OUT	14	0	24	1.25	93	4	90	80	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.
387	tAQ	37016	7:09	Au	15	1480	90	80	22400	294000	423	294000	0.161	67	OUT	13	0	24	1.24	92	5	90	80	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.
388	tAR	37016	7:09	Au	15	1480	90	80	22300	297000	428	297000	0.159	67	OUT	13	0	24	1.25	92	4	90	80	Current	Current	4.154	-0.06	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.
389	tAS	37016	7:10	Au	15	1480	90	80	22500	102000	148	102000	0.463	67	OUT	5	0	24	1.25	92	5	90	80	Current	Current	-4.494	2.101	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.
390	tAT	37016	7:12	Au	15	1480	90	80	23200	301000	434	301000	0.160	67	OUT	13	0	24	1.25	91	5	90	80	Current	Current	-1.108	2.142	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.
391	tAU	37016	7:12	Au	15	1480	90	80	23200	290000	418	290000	0.166	67	OUT	13	0	24	1.25	92	5	90	80	Current	Current	0.673	2.144	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.
392	tAV	37016	7:14	Au	15	1480	90	80	22800	309000	446	309000	0.155	67	OUT	14	0	24	1.25	93	5	90	80	Current	Current	2.691	2.144	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.
393	tAW	37016	7:14	Au	15	1480	90	80	22800	298000	430	298000	0.160	67	OUT	13	0	24	1.25	91	5	90	80	Current	Current	4.397	2.144	0	0.502	0.886	0.737	40.775	2	260	270	293	275	344	0	Nolayers.lay	None.

Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV/cm2/mg	Range µm	<Flux> #/cm2/sec	Fluence #/cm2	Dose RAD(Si)	E-fluor RAD(Si)	%err	Al(um)	USD	Live	Dead	BID	Gain	Unif	Shift	E-L-ET	E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments
384	IAP	45420	11:01	Xe	15	1278	53.7	101	11200	302000	259	302000	.11E-01	5	OUT	27	0	19	1.13	96	2	54	101	IR0805	Current	0.886	-2.454	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
385	IAD	45420	11:04	Xe	15	1278	53.7	101	11000	295000	257	295000	.11E-01	5	OUT	27	0	19	1.12	96	2	54	101	IR0805	Current	2.515	-2.427	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
386	IAR	45420	11:04	Xe	15	1278	53.7	101	11100	305000	262	305000	.10E-01	5	OUT	27	0	19	1.12	96	2	54	101	IR0805	Current	2.515	-2.427	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
387	IAS	45420	11:08	Xe	15	1278	53.7	101	11100	306000	263	306000	.09E-01	5	OUT	27	0	19	1.12	96	3	54	101	IR0805	Current	4.061	-2.427	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
388	IAT	45420	11:09	Xe	15	1278	53.7	101	11400	295000	254	295000	.14E-01	5	OUT	26	0	19	1.14	96	3	54	101	IR0805	Current	4.061	-2.427	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
389	IAU	45420	11:10	Xe	15	1278	53.7	101	11300	93300	80.3	93300	1.60E-01	5	OUT	8	0	19	1.14	95	3	54	101	IR0805	Current	4.061	-2.427	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
390	IAV	45420	11:16	Xe	15	1623	50.3	129	11400	305000	246	305000	0.111	0	OUT	27	0	19	1.08	94	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
391	IAW	45420	11:17	Xe	15	1623	50.3	129	11400	295000	238	295000	0.114	0	OUT	26	0	19	1.08	94	4	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
392	IAX	45420	11:21	Xe	15	1623	50.3	129	10900	302000	244	302000	0.109	0	OUT	28	0	19	1.1	95	2	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
393	IAY	45420	11:22	Xe	15	1623	50.3	129	11100	301000	243	301000	0.111	0	OUT	27	0	19	1.12	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
394	IAZ	45420	11:23	Xe	15	1623	50.3	129	11500	295000	238	295000	0.115	0	OUT	26	0	19	1.12	94	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
395	IB0	45420	11:24	Xe	15	1623	50.3	129	11800	296000	239	296000	0.116	0	OUT	25	0	19	1.12	94	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
396	IB1	45420	11:25	Xe	15	1623	50.3	129	11700	300000	242	300000	0.114	0	OUT	26	0	19	1.12	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
397	IB2	45420	11:25	Xe	15	1623	50.3	129	11900	305000	246	305000	0.113	0	OUT	26	0	19	1.15	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
398	IB3	45420	11:26	Xe	15	1623	50.3	129	12000	301000	243	301000	0.115	0	OUT	25	0	19	1.15	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
399	IB4	45420	11:27	Xe	15	1623	50.3	129	11800	296000	239	296000	0.116	0	OUT	25	0	19	1.13	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
400	IB5	45420	11:28	Xe	15	1623	50.3	129	11800	296000	239	296000	0.116	0	OUT	25	0	19	1.13	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
401	IB6	45420	11:28	Xe	15	1623	50.3	129	12200	296000	239	296000	0.118	0	OUT	24	0	19	1.16	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
402	IB7	45420	11:29	Xe	15	1623	50.3	129	11800	305000	246	305000	0.113	0	OUT	26	0	19	1.13	95	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
403	IB8	45420	11:33	Xe	15	1623	50.3	129	10900	304000	245	304000	0.108	0	OUT	28	0	19	1.13	94	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
404	IB9	45420	11:34	Xe	15	1623	50.3	129	11500	295000	238	295000	0.115	0	OUT	26	0	19	1.16	94	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
405	IBA	45420	11:35	Xe	15	1623	50.3	129	11800	301000	243	301000	0.114	0	OUT	25	0	19	1.17	94	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
406	IBB	45420	11:36	Xe	15	1623	50.3	129	11800	301000	243	301000	0.114	0	OUT	26	0	19	1.17	94	3	50	129	IR0805	sckt7	-3.876	-0.008	-5.671	0	1.765	1.75	0	0	282	335	307	304	358	0	IR0805.lay	None.
407	IBC	45420	11:44	Xe	15	1062	56.2	84	11000	305000	274	305000	.09E-01	0	OUT	28	0	19	1.22	95	3	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
408	IBD	45420	11:45	Xe	15	1062	56.2	84	10900	302000	272	302000	.09E-01	0	OUT	28	0	19	1.22	96	3	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
409	IBE	45420	11:49	Xe	15	1062	56.2	84	11100	305000	275	305000	.09E-01	0	OUT	28	0	19	1.24	95	3	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
410	IBF	45420	11:49	Xe	15	1062	56.2	84	11000	296000	267	296000	.12E-01	0	OUT	27	0	19	1.22	96	2	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
411	IBG	45420	11:50	Xe	15	1062	56.2	84	11100	298000	268	298000	.12E-01	0	OUT	27	0	19	1.23	96	2	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
412	IBH	45420	11:51	Xe	15	1062	56.2	84	11100	302000	272	302000	.10E-01	0	OUT	27	0	19	1.23	96	2	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
413	IBI	45420	11:52	Xe	15	1062	56.2	84	10800	304000	274	304000	.08E-01	0	OUT	28	0	19	1.2	96	2	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
414	IBJ	45420	11:53	Xe	15	1062	56.2	84	10100	300000	270	300000	.06E-01	0	OUT	30	0	19	1.2	96	3	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
415	IBK	45420	11:55	Xe	15	1062	56.2	84	10600	302000	272	302000	.08E-01	0	OUT	28	0	19	1.23	95	3	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
416	IBL	45420	11:56	Xe	15	1062	56.2	84	10800	297000	267	297000	.11E-01	0	OUT	28	0	19	1.24	95	3	56	84	IR0805	Current	-2.28	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
417	IBM	45420	12:00	Xe	15	1278	53.7	101	10900	298000	256	298000	.11E-01	5	OUT	27	0	19	1.19	95	3	54	101	IR0805	Current	-0.692	-0.008	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
418	IBN	45420	12:01	Xe	15	1278	53.7	101	10800	299000																															



Run #	Ext	Date	Time	Beam	MeV/u	Energy MeV	LET MeV/cm2/mg	Range μm	<Flux> #/cm2/sec	Fluence #/cm2	Dose RAD(Si)	E-fluor RAD(Si)	%err	A(um)	USD	Live	Dead	BID	Gain	Unif	Shift	E-LET E-range	Board	DUT	X(in)	Y(in)	Z(in)	T(deg)	U(in)	V(in)	R(deg)	S	V1	V2	V3	V4	V5	V6	Layers-file	Comments	
461	ICV	45420	13:33	Xe	15	1062	56.2	84	10100	301000	270	301000	.06E-01	0	OUT	30	0	19	1.28	92	5	56	84	IR0805	Current	2.483	2.369	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
462	ICW	45420	13:35	Xe	15	1062	56.2	84	10300	301000	271	301000	.07E-01	0	OUT	29	0	19	1.28	92	5	56	84	IR0805	Current	4.091	2.369	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
463	ICX	45420	13:36	Xe	15	1062	56.2	84	10000	298000	269	298000	.06E-01	0	OUT	30	0	19	1.25	93	5	56	84	IR0805	Current	4.091	2.369	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
464	ICY	45420	13:37	Xe	15	1062	56.2	84	9950	81200	73.1	81200	.188E-01	0	OUT	8	0	19	1.24	91	5	56	84	IR0805	Current	4.091	2.369	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
465	ICZ	45420	13:40	Xe	15	1062	56.2	84	9740	301000	271	301000	.04E-01	0	OUT	31	0	19	1.24	92	5	56	84	IR0805	Current	0.931	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
466	ID0	45420	13:40	Xe	15	1062	56.2	84	9700	303000	273	303000	.03E-01	0	OUT	31	0	19	1.24	92	5	56	84	IR0805	Current	0.931	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
467	ID1	45420	13:41	Xe	15	1062	56.2	84	9720	303000	273	303000	.03E-01	0	OUT	31	0	19	1.24	92	5	56	84	IR0805	Current	0.931	-0.008	-5.671	0	1.765	1.75	51.138	1	307	367	346	343	390	0	IR0805.lay	None.
468	ID2	45420	13:44	Xe	15	1278	53.7	101	9950	297000	255	297000	.06E-01	5	OUT	30	0	19	1.22	92	5	54	101	IR0805	Current	2.507	-0.008	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
469	ID3	45420	13:46	Xe	15	1278	53.7	101	10000	303000	261	303000	.04E-01	5	OUT	30	0	19	1.22	92	5	54	101	IR0805	Current	2.507	-0.008	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
470	ID4	45420	13:47	Xe	15	1278	53.7	101	10000	297000	255	297000	.07E-01	5	OUT	30	0	19	1.22	92	5	54	101	IR0805	Current	2.507	-0.008	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
471	ID5	45420	13:48	Xe	15	1278	53.7	101	9690	304000	261	304000	.03E-01	5	OUT	31	0	19	1.19	92	5	54	101	IR0805	Current	2.507	-0.008	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
472	ID6	45420	13:49	Xe	15	1278	53.7	101	9730	276000	238	276000	.13E-01	5	OUT	28	0	19	1.19	91	5	54	101	IR0805	Current	2.507	-0.008	-5.671	0	1.765	1.75	2.975	1	296	353	329	326	376	0	IR0805.lay	None.
473	ID7	45420	13:55	Xe	15	1150	55.2	90	9820	299000	265	299000	.05E-01	4	OUT	31	0	19	1.23	92	5	55	90	IR0805	Current	4.118	-0.008	-5.671	0	1.765	1.75	42.463	1	302	361	339	336	384	0	IR0805.lay	None.
474	ID8	45420	13:56	Xe	15	1150	55.2	90	9780	302000	267	302000	.04E-01	4	OUT	31	0	19	1.22	92	5	55	90	IR0805	Current	4.118	-0.008	-5.671	0	1.765	1.75	42.463	1	302	361	339	336	384	0	IR0805.lay	None.
475	ID9	45420	13:57	Xe	15	1150	55.2	90	9810	298000	264	298000	.05E-01	4	OUT	30	0	19	1.22	91	5	55	90	IR0805	Current	4.118	-0.008	-5.671	0	1.765	1.75	42.463	1	302	361	339	336	384	0	IR0805.lay	None.
476	IDA	45420	13:57	Xe	15	1150	55.2	90	9780	298000	263	298000	.05E-01	4	OUT	30	0	19	1.22	92	5	55	90	IR0805	Current	4.118	-0.008	-5.671	0	1.765	1.75	42.463	1	302	361	339	336	384	0	IR0805.lay	None.
477	IDB	45420	13:58	Xe	15	1150	55.2	90	9660	299000	264	299000	.04E-01	4	OUT	31	0	19	1.21	91	6	55	90	IR0805	Current	4.118	-0.008	-5.671	0	1.765	1.75	42.463	1	302	361	339	336	384	0	IR0805.lay	None.
478	IDC	45420	13:59	Xe	15	1150	55.2	90	9650	300000	265	300000	.04E-01	4	OUT	31	0	19	1.21	91	5	55	90	IR0805	Current	4.118	-0.008	-5.671	0	1.765	1.75	42.463	1	302	361	339	336	384	0	IR0805.lay	None.
479	IDD	45420	14:00	Xe	15	1150	55.2	90	9800	298000	263	298000	.05E-01	4	OUT	30	0	19	1.22	92	5	55	90	IR0805	Current	4.118	-0.008	-5.671	0	1.765	1.75	42.463	1	302	361	339	336	384	0	IR0805.lay	None.
480	IDE	45420	14:05	Xe	15	1623	50.3	129	10200	297000	240	297000	0.107	0	OUT	29	0	19	1.19	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
481	IDF	45420	14:06	Xe	15	1623	50.3	129	10300	295000	238	295000	0.109	0	OUT	29	0	19	1.19	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
482	IDG	45420	14:07	Xe	15	1623	50.3	129	10200	304000	243	304000	0.105	0	OUT	30	0	19	1.19	90	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
483	IDH	45420	14:07	Xe	15	1623	50.3	129	9990	297000	240	297000	0.106	0	OUT	30	0	19	1.19	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
484	IDI	45420	14:08	Xe	15	1623	50.3	129	10100	302000	243	302000	0.105	0	OUT	30	0	19	1.19	92	5	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
485	IDJ	45420	14:09	Xe	15	1623	50.3	129	10300	302000	244	302000	0.106	0	OUT	29	0	19	1.19	91	5	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
486	IDK	45420	14:10	Xe	15	1623	50.3	129	9870	296000	238	296000	0.106	0	OUT	30	0	19	1.16	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
487	IDL	45420	14:11	Xe	15	1623	50.3	129	9900	300000	242	300000	0.105	0	OUT	30	0	19	1.16	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
488	IDM	45420	14:12	Xe	15	1623	50.3	129	9790	302000	243	302000	0.104	0	OUT	31	0	19	1.16	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
489	IDN	45420	14:12	Xe	15	1623	50.3	129	9920	301000	242	301000	0.105	0	OUT	30	0	19	1.17	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
490	IDO	45420	14:13	Xe	15	1623	50.3	129	9930	300000	242	300000	0.105	0	OUT	30	0	19	1.17	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
491	IDP	45420	14:14	Xe	15	1623	50.3	129	9960	302000	244	302000	0.104	0	OUT	30	0	19	1.17	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
492	IDQ	45420	14:15	Xe	15	1623	50.3	129	9160	303000	245	303000	0.100	0	OUT	33	0	19	1.16	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
493	IDR	45420	14:16	Xe	15	1623	50.3	129	9550	297000	240	297000	0.104	0	OUT	31	0	19	1.16	90	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
494	IDS	45420	14:17	Xe	15	1623	50.3	129	9780	303000	244	303000	0.103	0	OUT	31	0	19	1.16	91	6	50	129	IR0805	Current	-3.896	2.369	-5.671	0	1.765	1.75	42.463	0	282	335	307	304	358	0	IR0805.lay	None.
495	IDT	45420	14:18	Xe	15	1623	50.3																																		

# Appendix C

## International Rectifier

### Test Plan

and

### Procedure

## April 2005 Test Plan, Single Event Effects (TAMU, K500 Superconducting Cyclotron)

### 1.0 Purpose

The purpose of this test is to characterize and establish Single Event Effects (SEE) Safe-Operating-Area (SOA) curves for several International Rectifier Corp. (IR) Power MOSFET devices. The data resulting from the tests shall be used for qualification to several US Government military slash sheets and shall be incorporated in the IR data sheets.

### 2.0 Test Responsibility

IR shall be responsible for conducting the tests, which shall be performed at the Texas A & M University (TAMU), Cyclotron Institute. IR shall be responsible for the SEE testing of devices-under-test (DUT) and final Test Report.

### 3.0 Test Facility

#### 3.1 K500 Superconducting Cyclotron

The Texas A&M University, Tandem K500 Superconducting Cyclotron shall be used to provide the necessary ion species and energy. TAMU Cyclotron Institute shall provide adequate dosimeter for verification of the ion beam parameters.

#### 3.2 Test Equipment

The necessary test equipment including the test interface board, cables, power supplies, etc. shall be provided by IR. IR shall provide the equipment needed to de-lid and handle the individual test devices.

### 4.0 Test Devices

4.1 The following device types are planned for characterization and qualification:

IRH67C30	(Hex-3, 600V, N-channel, R6, MR Process)
IRH67264	(Hex-6, 250V, N-channel, R6, MR Process)
IRHL77214	(Hex-1, 250V, N-channel, R7 Logic, MR Process)

4.2 All devices shall be built in TO-3 packages. The devices shall be properly sealed and packed for transportation to TAMU Cyclotron Institute.

4.3 All devices shall be verified for correct electrical performance prior to arrival at TAMU Cyclotron.

### 5.0 Test Method

The MIL-STD-750, Method 1080 shall be used to set procedure for all testing described herein.

### 6.0 Ion Specie and Energy

There are three (3) available ion specie with different energy level, at TAMU. All parts will be first tested with one specie of lowest energy (LET) level before the Accelerator is switched to the next ion specie with higher energy level.

a. Xenon	$_{54}\text{Xe}^{131}$	Energy = 2441 MeV	LET = 43 MeV/(mg/cm <sup>2</sup> )	Range = 205 $\mu\text{m}$
b. Silver	$_{47}\text{Ag}^{109}$	Energy = 1217 MeV	LET = 43 MeV/(mg/cm <sup>2</sup> )	Range = 112 $\mu\text{m}$
c. Xenon	$_{54}\text{Xe}^{131}$	Energy = 825 MeV	LET = 59 MeV/(mg/cm <sup>2</sup> )	Range = 66 $\mu\text{m}$
d. Gold	$_{79}\text{Au}^{197}$	Energy = 1480 MeV	LET = 90 MeV/(mg/cm <sup>2</sup> )	Range = 80 $\mu\text{m}$



## 7.0 Record Keeping

Each irradiation shall be assigned a run number. This number will be used to correlate data from different sources.

### 7.1 Cyclotron Accelerator Output

The K500 Cyclotron Institute shall provide a hardcopy summary of all test runs showing key parameters such as run, date, time, flux, fluence, ion, energy, LET, and range. An output of beam diagnostics shall also be provided.

### 7.2 IR Output

IR shall also keep a written log of each run including run, ion, device tested, VDS and VGS biases. IR shall also record comments regarding the test including observations or deviations from test plan.

## 8.0 Characterizations and Verification

Characterization and Verification may be accomplished simultaneously. Characterization implies that the SOA curve is set using at least one (1) device at each insitu bias. Verification is simply an extension of the characterization, demonstrating total three (3) non-destructive devices passing at each insitu bias condition.

## 9.0 Test Procedure

The IR Product Engineer assigned to this test shall control the following test procedure based on Test Method 1080. IR shall be responsible to direct the ion specie, beam characteristics, insitu bias conditions and device selection.

9.1 Nominal Beam Characteristics are :  
Flux =  $1 \times 10^4$  (1E4) ions/cm<sup>2</sup>/sec.  
Fluence =  $3 \times 10^5$  (3E5) ions/cm<sup>2</sup>.  
Beam Diameter = 1.5 cm.  
(or large enough to cover the whole die-attachment area)

9.2 Initial Starting Point : typically at VDS = Rated VDS and VGS = 0.

9.3 Irradiate the device at the selected flux and fluence.

9.4 Post irradiation, test IDSS & IGSS at VDS=80% Rated VDS and VGS up to 20 V (5 V increment).

9.5 Based on apparent pass or fail, select next operating conditions.

9.6 Repeat with new device.

## 10. Test Report

The Test Report shall include the following information :

- a. Device Type(s), serial numbers, wafer lot identification, date code (if applicable).
- b. Test dates and personnel names.
- c. Facility, accelerator type.
- d. Ion specie, energy, LET, range, flux and fluence.
- e. Schematic of test circuit used.
- f. Dosimeter for each ion beam used.
- g. Insitu bias conditions.
- h. Comments and observations.
- i. Pre and post electrical test results.
- j. Summary description including curves.

## August 2005 Test Plan, Single Event Effects (TAMU, K500 Superconducting Cyclotron)

### 1.0 Purpose

The purpose of this test is to characterize and establish Single Event Effects (SEE) Worst-case Beam Test Conditions for several International Rectifier Corp. (IR) Power MOSFET devices. The data resulting from the tests shall be used for studying SEE Sensitivity of the IR RH MOSFET designs related to SEE Beam Bragg Peak penetration depth.

### 2.0 Test Responsibility

IR shall be responsible for conducting the tests, which shall be performed at the Texas A & M University (TAMU), Cyclotron Institute. IR shall be responsible for the SEE testing of devices-under-test (DUT) and final Test Report.

### 3.0 Test Facility

#### 3.1 K500 Superconducting Cyclotron

The Texas A&M University, Tandem K500 Superconducting Cyclotron shall be used to provide the necessary ion species and energy. TAMU Cyclotron Institute shall provide adequate dosimeter for verification of the ion beam parameters.

#### 3.2 Test Equipment

The necessary test equipment including the test interface board, cables, power supplies, etc. shall be provided by IR. IR shall provide the equipment needed to de-lid and handle the individual test devices.

### 4.0 Test Devices

4.1 The following device types are planned for characterization and qualification:

IRH67C30 (Hex-3, 600V, N-channel, R6, MR Process)

IRH67264 (Hex-6, 250V, N-channel, R6, MR Process)

4.2 All devices shall be built in TO-3 packages. The devices shall be properly sealed and packed for transportation to TAMU Cyclotron Institute.

4.3 All devices shall be verified for correct electrical performance prior to arrival at TAMU Cyclotron.

### 5.0 Test Method

The MIL-STD-750, Method 1080 shall be used to set procedure for all testing described herein.

### 6.0 Ion Specie and Energy

There are three (3) available ion specie with different energy level, at TAMU. All parts will be first tested with one specie of lowest energy (LET) level before the Accelerator is switched to the next ion specie with higher energy level.

a. Krypton  ${}_{54}\text{Kr}^{84}$  Energy = 300-2000 MeV LET = 20-40 MeV/(mg/cm<sup>2</sup>) Range = 40-300  $\mu\text{m}$

b. Xenon  ${}_{54}\text{Xe}^{131}$  Energy = 825 MeV LET = 59 MeV/(mg/cm<sup>2</sup>) Range = 66  $\mu\text{m}$

c. Gold  ${}_{79}\text{Au}^{197}$  Energy = 1480 MeV LET = 90 MeV/(mg/cm<sup>2</sup>) Range = 80  $\mu\text{m}$

By using Air Gap as additional degrader together with cyclotron's degrader foil system, various beam conditions can be selected to put the beam Bragg Peak at or between each sensitive depth (junction, first epi, buffer, substrate)

## 7.0 Record Keeping

Each irradiation shall be assigned a run number. This number will be used to correlate data from different sources.

### 7.1 Cyclotron Accelerator Output

The K500 Cyclotron Institute shall provide a hardcopy summary of all test runs showing key parameters such as run, date, time, flux, fluence, ion, energy, LET, and range. An output of beam diagnostics shall also be provided.

### 7.2 IR Output

IR shall also keep a written log of each run including run, ion, device tested, VDS and VGS biases. IR shall also record comments regarding the test including observations or deviations from test plan.

## 8.0 Characterizations and Verification

Characterization and Verification may be accomplished simultaneously. Characterization implies that the SOA curve is set using at least one (1) device at each insitu bias. Verification is simply an extension of the characterization, demonstrating total three (3) non-destructive devices passing at each insitu bias condition.

## 9.0 Test Procedure

The IR Product Engineer assigned to this test shall control the following test procedure based on Test Method 1080. IR shall be responsible to direct the ion specie, beam characteristics, insitu bias conditions and device selection.

9.1 Nominal Beam Characteristics are :  
Flux =  $1 \times 10^4$  (1E4) ions/cm<sup>2</sup>/sec.  
Fluence =  $3 \times 10^5$  (3E5) ions/cm<sup>2</sup>.  
Beam Diameter = 1.5 cm.  
(or large enough to cover the whole die-attachment area)

9.2 Initial Starting Point : typically at VDS = Rated VDS and VGS = 0.

9.3 Irradiate the device at the selected flux and fluence.

9.4 Post irradiation, test IDSS & IGSS at VDS=80% Rated VDS and VGS up to 20 V (5 V increment).

9.5 Based on apparent pass or fail, select next operating conditions.

9.6 Repeat with new device.

## 10. Test Report

The Test Report shall include the following information :

- a. Device Type(s), serial numbers, wafer lot identification, date code (if applicable).
- b. Test dates and personnel names.
- c. Facility, accelerator type.
- d. Ion specie, energy, LET, range, flux and fluence.
- e. Schematic of test circuit used.
- f. Dosimeter for each ion beam used.
- g. Insitu bias conditions.
- h. Comments and observations.
- i. Pre and post electrical test results.
- j. Summary description including curves.

# Appendix D

## Test Circuit

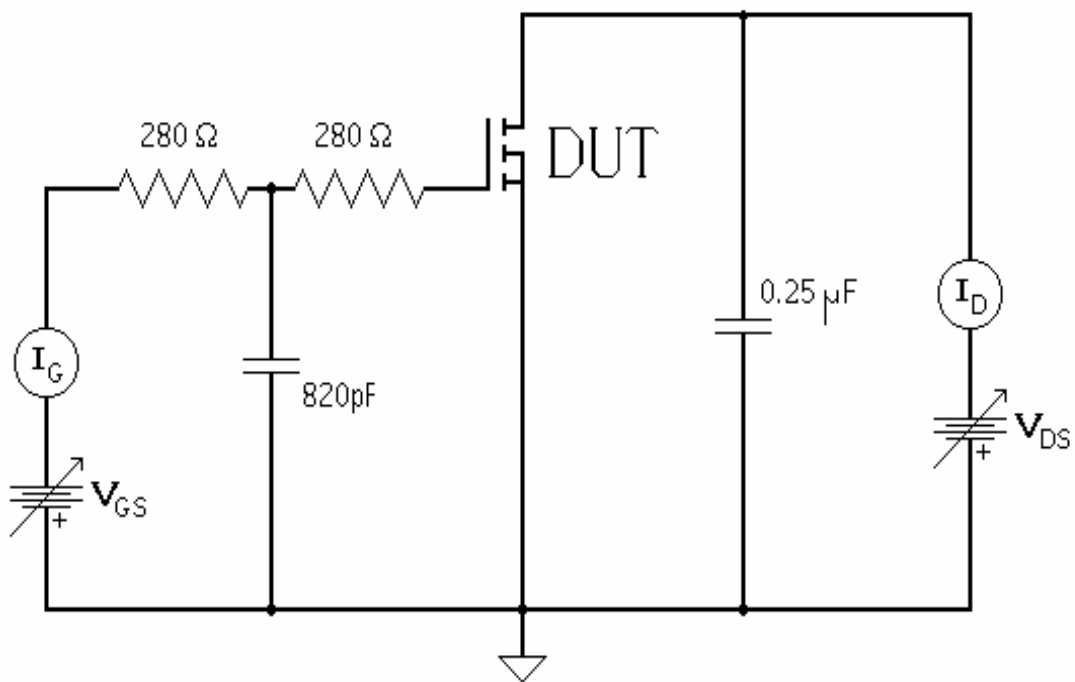
### Schematic

### Diagram

Reference: MIL-STD-750, Method 1080

Details of Test Method can be reviewed from DSCC Website:

[http://www.dsccl.dla.mil/Downloads/MilSpec/Docs/MIL-STD-750/std750\\_1000.pdf](http://www.dsccl.dla.mil/Downloads/MilSpec/Docs/MIL-STD-750/std750_1000.pdf)





Test Circuit Schematic Diagram

# Appendix E

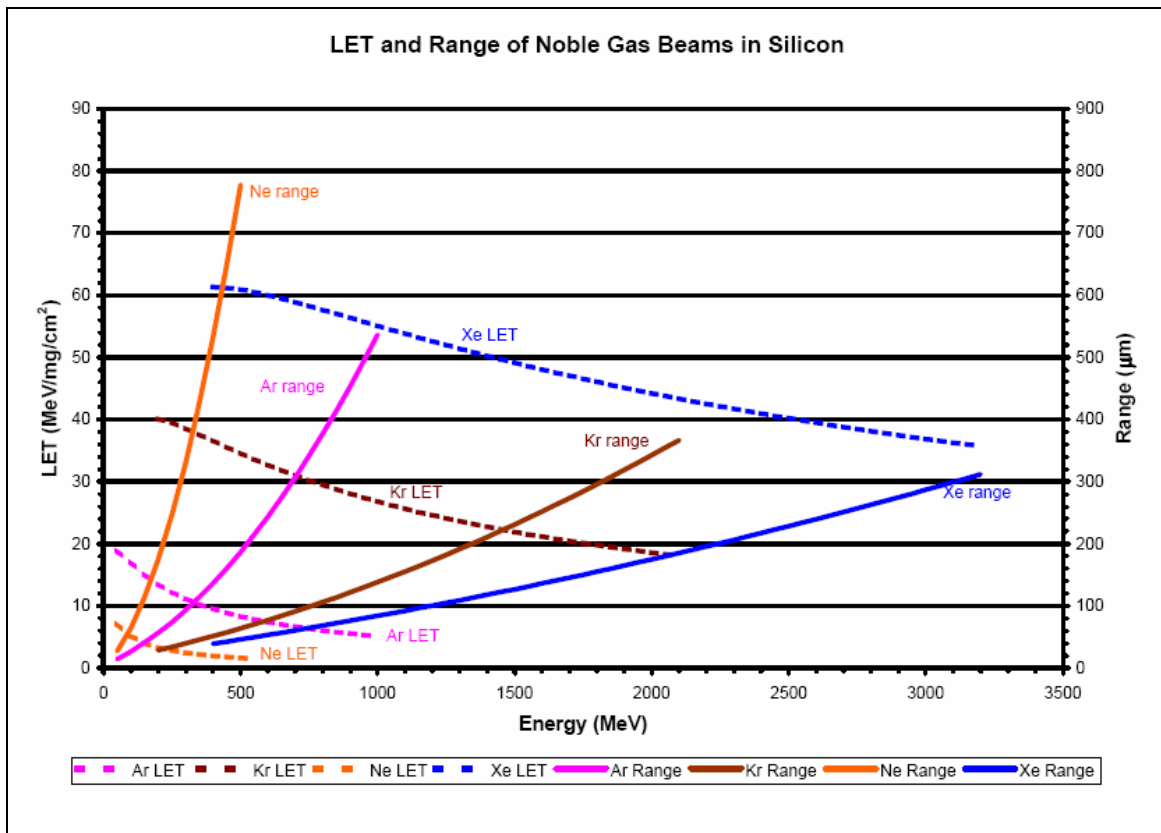
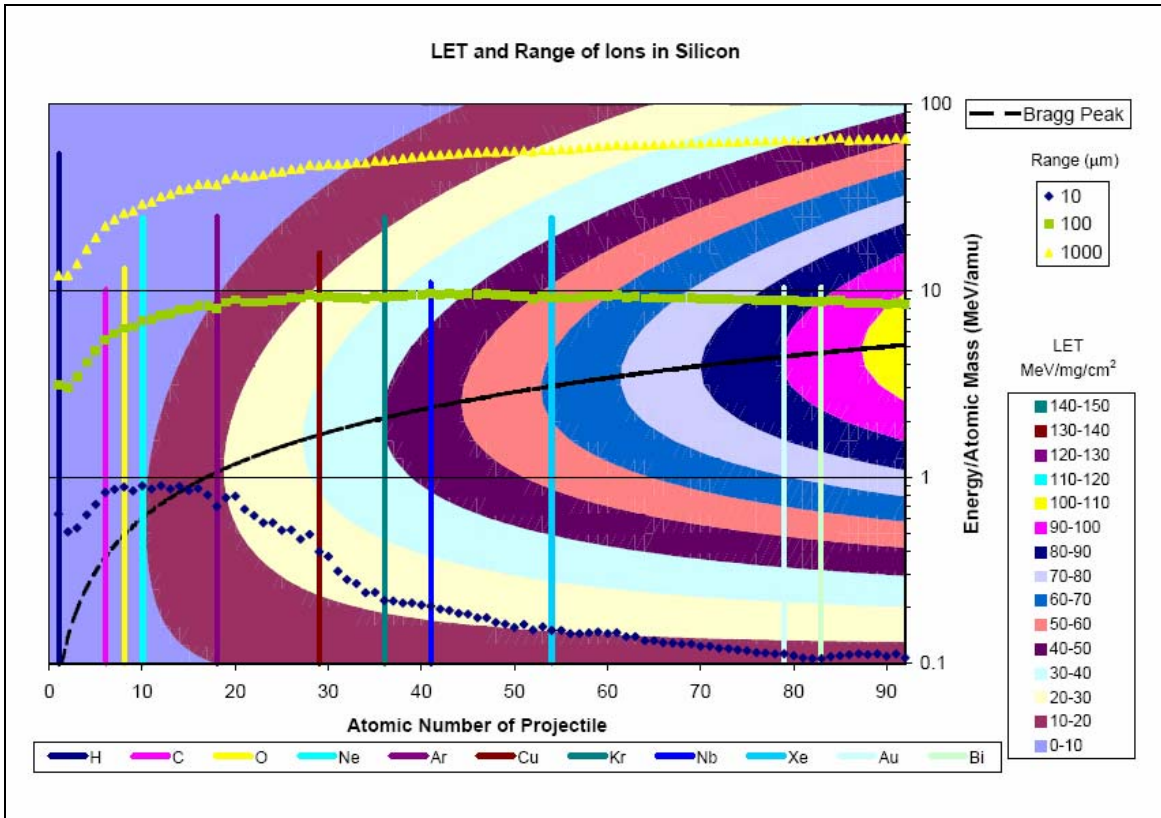
## TAMU K500 Cyclotron

### Ion Species, Surface LET and Range

 Cyclotron Institute • Texas A&M University  
**Radiation Effects Facility**   
**Available Beams**

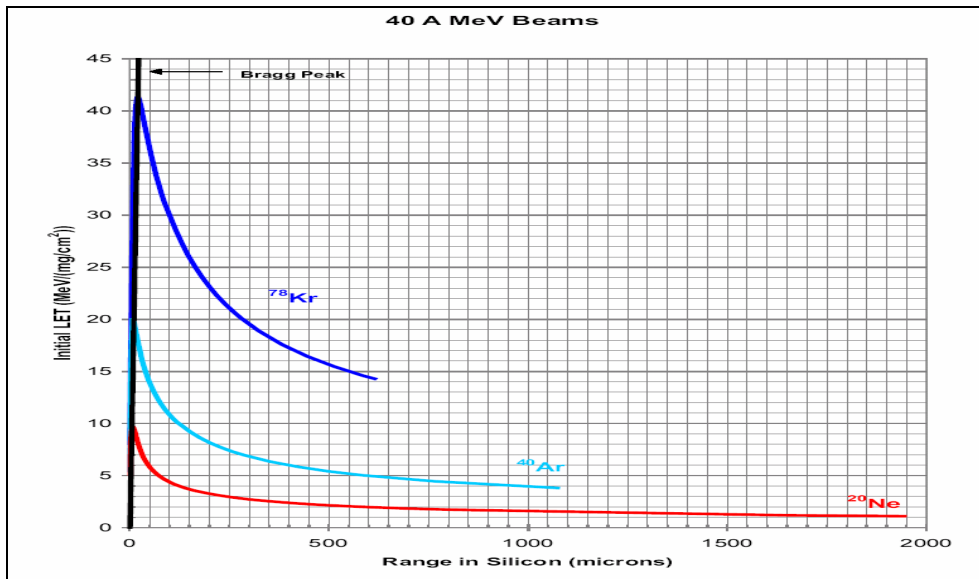
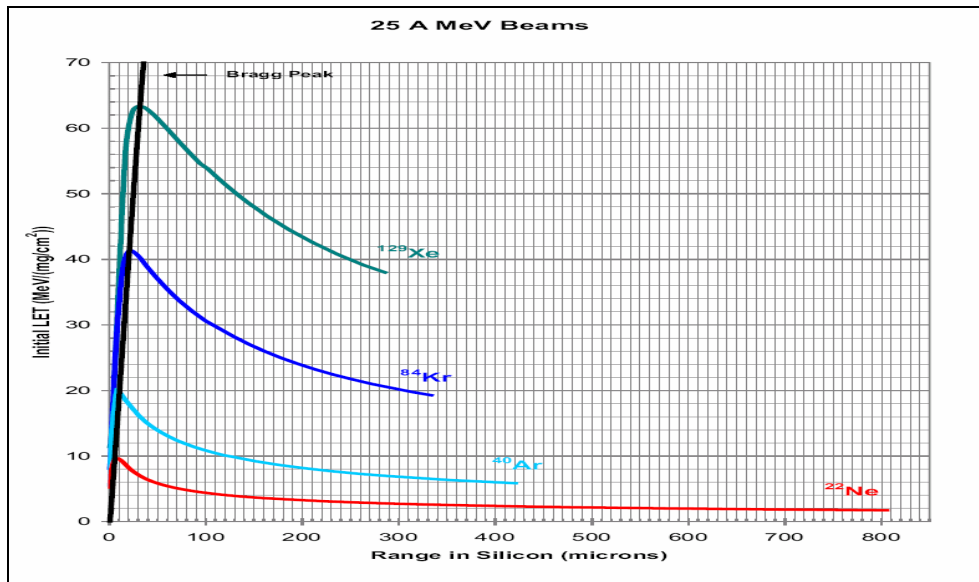
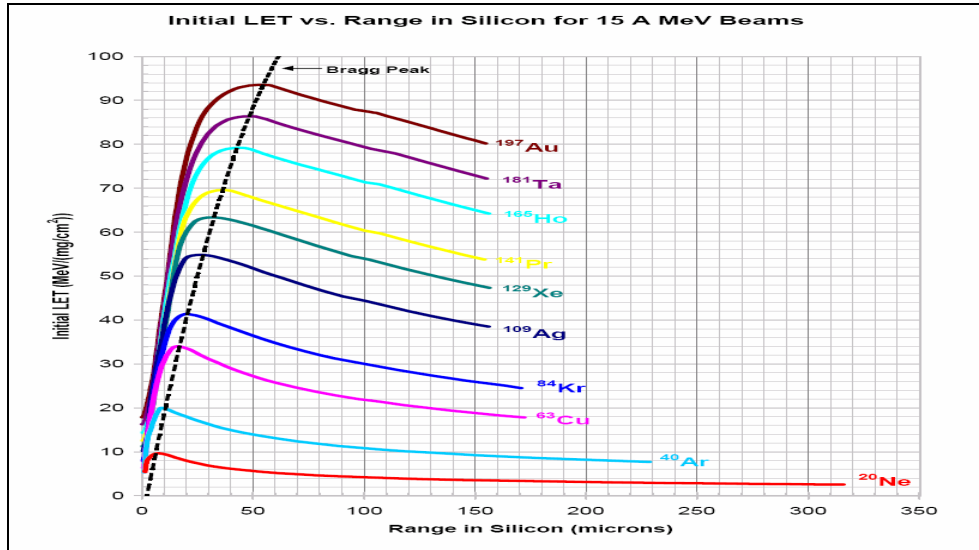
Particle	A MeV	LET <sub>init</sub> (MeV/mg/cm <sup>2</sup> )	LET <sub>Bragg</sub> (MeV/mg/cm <sup>2</sup> )	Range <sub>Bragg</sub> (microns)
<sup>20</sup> Ne	15	2.5	9.6	305
<sup>40</sup> Ar	"	7.7	20.1	220
<sup>63</sup> Cu	"	17.8	34.0	156
<sup>84</sup> Kr	"	25.4	41.4	154
<sup>109</sup> Ag	"	38.5	54.8	130
<sup>129</sup> Xe	"	47.3	63.4	127
<sup>141</sup> Pr	"	53.8	69.6	117
<sup>165</sup> Ho	"	64.3	79.2	112
<sup>181</sup> Ta	"	72.2	86.4	107
<sup>197</sup> Au	"	80.2	93.5	102
<sup>22</sup> Ne	24.8	1.7	9.7	790
<sup>40</sup> Ar	"	5.4	20.1	491
<sup>84</sup> Kr	"	19.3	41.4	315
<sup>129</sup> Xe	"	37.9	63.4	254
proton	40	0.012	0.58	8147
<sup>20</sup> Ne	"	1.2	9.7	1648
<sup>40</sup> Ar	"	3.8	20.1	1070
<sup>78</sup> Kr	"	14.2	41.4	601
<sup>16</sup> O	55.1	0.59	7.4	3607
<sup>36</sup> Ar	"	3.0	20.1	1665

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# Appendix F

## Post-SEE

### Electrical

### Measurements

RadHard MOSFET - R6, Hex 6, 250V, N-channel												
Expected Good Devices			Post - SEE Electricals Data									
SEE-Failed Devices			Post-Electricals									
Parameter	I GSSf	I GSSr	I DSS	BV DSS	V GS(th)	R DS(on)	VSD	GFS	I DSS	I GSSf	I GSSr	
Conditions	VGS=20V VDS=0V	VGS=-20V VDS=0V	VDS=200V VGS=0V	IDSS=1mA	VDS=VGS ID=1mA	ID=56A VGS=12V	IS=56A	ID=56A VDS=15V	VDS=20V VGS=0V	VGS=-20V VDS=0V	VGS=-V VDS=0V	
Limits	100nA Max	-100nA Max	10µA Max	250 V Min	2 V to 4 V	< 61 mOhms	1.2 V Max	27 Mhos Min	0.1µA Max	100nA Max	0nA Max	
Unit	nA	nA	µA	V	V	mOhms	V	Mhos	µA	nA	nA	
SEE Id	Log Serial											
A2		6.76	2.01	2.802	280.3	3.168	35.53	0.988	69.13	0.007	2.04	0.00
A3		6.80	1.94	2.821	279.1	3.136	34.80	0.993	69.13	0.007	2.07	0.00
A5		6.79	2.05	2.752	281.7	3.125	34.85	0.996	69.13	0.007	2.00	0.00
A6		6.86	2.06	2.789	285.0	3.131	36.73	0.990	71.79	0.007	1.97	0.00
A7		6.80	1.99	2.825	280.1	3.183	36.55	0.997	69.13	0.007	2.18	0.00
A8		6.64	2.02	2.799	279.0	3.160	34.94	0.997	68.29	0.007	1.98	0.00
A9		6.88	2.04	4.544	261.2	3.132	34.26	0.995	69.13	0.007	1.97	0.00
A10		7.08	2.09	2.893	272.9	3.216	33.64	0.996	61.53	0.007	2.02	0.00
A11		6.70	1.97	2.684	278.9	3.242	35.71	0.999	57.14	0.007	1.96	0.00
A12		6.78	1.89	2.843	272.4	3.234	33.53	0.989	62.22	0.007	1.90	0.00
A14		6.94	1.93	2.802	275.0	3.155	34.35	0.993	70.00	0.007	2.03	0.00
A15		6.81	2.02	2.911	274.4	3.199	34.51	0.994	55.44	0.007	1.98	0.00
A16		6.84	2.01	2.902	274.1	3.193	34.42	0.993	57.14	0.007	2.02	0.00
A17		6.99	2.05	2.843	274.9	3.179	33.10	0.989	65.11	0.007	2.03	0.00
A18		7.07	2.05	2.601	279.7	3.068	35.39	0.992	66.66	0.007	2.01	0.00
A19		6.71	1.96	2.570	279.7	3.202	35.10	0.993	68.29	0.007	1.92	0.00
A20		6.80	2.05	2.635	278.6	3.216	35.87	1.000	63.63	0.007	1.98	0.00
A22		6.85	2.01	2.819	278.6	3.226	36.75	0.999	48.27	0.007	2.04	0.00
A23		6.85	2.01	2.644	279.2	3.239	36.21	0.996	52.33	0.007	1.94	0.00
A24		6.91	2.00	2.933	274.6	3.239	34.16	0.998	60.86	0.007	1.97	0.00
A27		6.82	1.96	2.799	280.9	3.239	36.03	0.996	63.63	0.007	1.97	0.00
A28		6.93	1.96	2.876	280.6	3.221	35.69	0.998	65.11	0.007	1.92	0.00
A31		6.59	1.96	2.771	282.7	3.266	36.69	0.998	63.63	0.007	1.96	0.00
A35		6.85	1.98	2.926	277.3	3.108	33.91	0.990	70.00	0.007	2.01	0.00
A36		6.99	2.07	2.682	281.4	3.265	35.64	0.990	65.11	0.007	2.29	0.00
A37		6.91	1.95	2.505	283.1	3.207	35.91	0.991	65.88	0.007	2.06	0.00

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